

LPC2917/19

ARM9 microcontroller with CAN and LIN

Rev. 1.01 — 15 November 2007

Preliminary data sheet

1. Introduction

1.1 About this document

This document lists detailed information about the LPC2917/19 device. It focuses on factual information like pinning, characteristics etc. Short descriptions are used to outline the concept of the features and functions. More details and background on developing applications for this device are given in the LPC2917/19 User Manual (see <u>Ref. 1</u>). No explicit references are made to the User Manual.

1.2 Intended audience

This document is written for engineers evaluating and/or developing systems, hardand/or software for the LPC2917/19. Some basic knowledge of ARM processors and architecture and ARM968E-S in particular is assumed (see <u>Ref. 2</u>).

2. General description

2.1 Architectural overview

The LPC2917/19 consists of:

- An ARM968E-S processor with real-time emulation support
- An AMBA multi-layer Advanced High-performance Bus (AHB) for interfacing to the on-chip memory controllers
- Two DTL buses (a universal NXP interface) for interfacing to the interrupt controller and the Power, Clock and Reset Control cluster (also called subsystem)
- Three VLSI Peripheral Buses (VPB a compatible superset of ARM's AMBA advanced peripheral bus) for connection to on-chip peripherals clustered in subsystems.

The LPC2917/19 configures the ARM968E-S processor in little-endian byte order. All peripherals run at their own clock frequency to optimize the total system power consumption. The AHB2VPB bridge used in the subsystems contains a write-ahead buffer one transaction deep. This implies that when the ARM968E-S issues a buffered write action to a register located on the VPB side of the bridge, it continues even though the actual write may not yet have taken place. Completion of a second write to the same subsystem will not be executed until the first write is finished.



2.2 ARM968E-S processor

N and L. The ARM968E-S is a general purpose 32-bit RISC processor, which offers high performance and very low power consumption. The ARM architecture is based on Reduced Instruction Set Computer (RISC) principles, and the instruction set and related decode mechanism are much simpler than those of micro-programmed Complex Instruction Set Computers (CISC). This simplicity results in a high instruction throughput and impressive real-time interrupt response from a small and cost-effective controller core.

Amongst the most compelling features of the ARM968E-S are:

- Separate directly connected instruction and data Tightly Coupled Memory (TCM) interfaces
- Write buffers for the AHB and TCM buses
- Enhanced 16 x 32 multiplier capable of single-cycle MAC operations and 16-bit fixedpoint DSP instructions to accelerate signal-processing algorithms and applications.

Pipeline techniques are employed so that all parts of the processing and memory systems can operate continuously. The ARM968E-S is based on the ARMv5TE five-stage pipeline architecture. Typically, in a three-stage pipeline architecture, while one instruction is being executed its successor is being decoded and a third instruction is being fetched from memory. In the five-stage pipeline additional stages are added for memory access and write-back cycles.

The ARM968E-S processor also employs a unique architectural strategy known as THUMB, which makes it ideally suited to high-volume applications with memory restrictions or to applications where code density is an issue.

The key idea behind THUMB is that of a super-reduced instruction set. Essentially, the ARM968E-S processor has two instruction sets:

- Standard 32-bit ARMv5TE set
- 16-bit THUMB set

The THUMB set's 16-bit instruction length allows it to approach twice the density of standard ARM code while retaining most of the ARM's performance advantage over a traditional 16-bit controller using 16-bit registers. This is possible because THUMB code operates on the same 32-bit register set as ARM code.

THUMB code can provide up to 65 % of the code size of ARM, and 160 % of the performance of an equivalent ARM controller connected to a 16-bit memory system.

The ARM968E-S processor is described in detail in the ARM968E-S data sheet Ref. 2.

2.3 On-chip flash memory system

The LPC2917/19 includes a 512 kB or 768 kB flash memory system. This memory can be used for both code and data storage. Programming of the flash memory can be accomplished in several ways. It may be programmed in-system via a serial port; e.g. CAN.

2.4 On-chip static RAM

In addition to the two 16 kB TCMs the LPC2917/19 includes two static RAM memories: one of 32 kB and one of 16 kB. Both may be used for code and/or data storage. Each internal SRAM has its own controller, so both memories can be accessed simultaneously from different AHB system bus layers.

3. Features

3.1 General

- ARM968E-S processor at 80 MHz maximum
- Multi-layer AHB system bus at 80 MHz with three separate layers
- On-chip memory:
 - Two Tightly Coupled Memories (TCM), 16 kB Instruction (ITCM), 16 kB Data TCM (DTCM)
 - Two separate internal Static RAM (SRAM) instances; 32 kB SRAM and 16 kB SRAM
 - Up to 768 kB flash-program memory
- Two-channel CAN controller supporting Full-CAN and extensive message filtering
- Two LIN master controllers with full hardware support for LIN communication
- Two 550 UARTs with 16-byte Tx and Rx FIFO depths
- Three full-duplex Q-SPIs with four slave-select lines; 16 bits wide; 8 locations deep; Tx FIFO and Rx FIFO
- Four 32-bit timers each containing four capture-and-compare registers linked to I/Os
- **32**-bit watchdog with timer change protection, running on safe clock.
- Up to 108 general-purpose I/O pins with programmable pull-up, pull-down or bus keeper
- Vectored Interrupt Controller (VIC) with 16 priority levels
- Two 8-channel 10-bit ADCs provide a total of up to 16 analog inputs, with conversion times as low as 2.44 µs per channel. Each channel provides a compare function to minimize interrupts
- Up to 24 level-sensitive external interrupt pins, including CAN and LIN wake- up features
- External Static Memory Controller (SMC) with eight memory banks; up to 32-bit data bus; up to 24-bit address bus
- Processor wake-up from power-down via external interrupt pins; CAN or LIN activity
- Flexible Reset Generator Unit (RGU) able to control resets of individual modules
- Flexible Clock-Generation Unit (CGU) able to control clock frequency of individual modules
 - On-chip very low-power ring oscillator; fixed frequency of 0.4 MHz; always on to provide a Safe_Clock source for system monitoring
 - On-chip crystal oscillator with operating range from 10 MHz to 50 MHz max. PLL input 15 MHz
 - On-chip PLL allows CPU operation up to a maximum CPU rate of 80 MHz
 - Generation of up to 10 base clocks
 - Seven fractional dividers

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- Highly configurable system Power Management Unit (PMU),
 - clock control of individual modules
 - allows minimization of system operating power consumption in any configuration
- Standard ARM test and debug interface with real-time in-circuit emulator
- Boundary-scan test supported
- Dual power supply:
 - CPU operating voltage: 1.8 V ± 5%
 - I/O operating voltage: 2.7 V to 3.6 V; inputs tolerant up to 5.5 V
- 144-pin LQFP package
- -40 °C to 85 °C ambient operating temperature range

Ordering information 4.

Table 1. **Ordering information**

Type number	Package					
	Name	Description	Version			
LPC2917FBD144	LQFP144	plastic low profile quad flat package; 144 leads; body 20 \times 20 \times 1.4 mm, pin pitch 0.5 mm	SOT486-1			
LPC2919FBD144	LQFP144	plastic low profile quad flat package; 144 leads; body 20 \times 20 \times 1.4 mm, pin pitch 0.5 mm	SOT486-1			

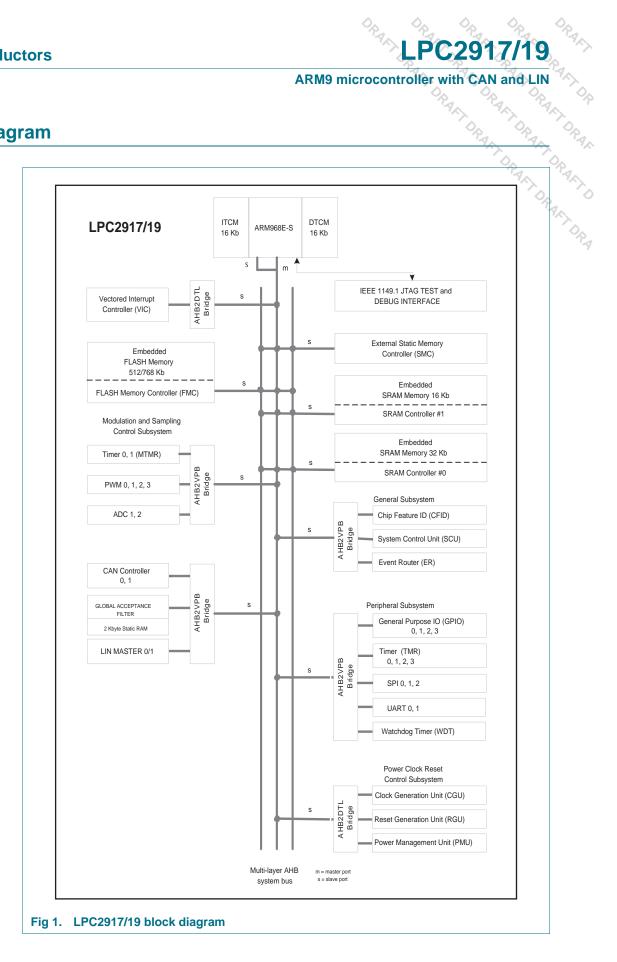
4.1 Ordering options

Table 2. **Part options**

Type number	Flash memory (kB)	RAM (kB)	SMC	LIN 2.0	Package
LPC2917FBD144	512	80 (incl TCMs)	32-bit	2	LQFP144
LPC2919FBD144	768	80 (incl TCMs)	32-bit	2	LQFP144

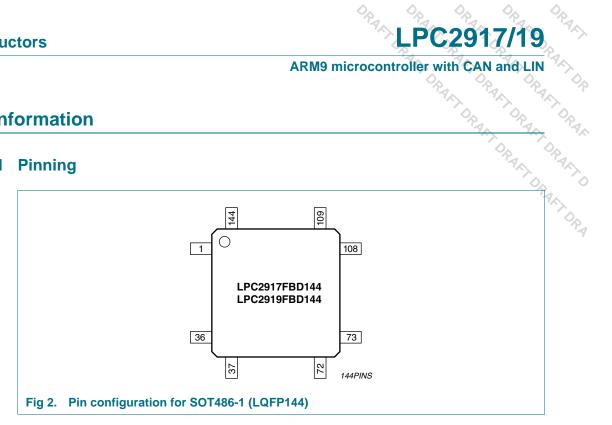


5. **Block diagram**



Pinning information 6.

6.1 Pinning



6.2 Pin description

6.2.1 General description

The LPC2917/19 has up to four ports: two of 32 pins each, one of 28 pins and one of 16 pins. The pin to which each function is assigned is controlled by the SFSP registers in the SCU. The functions combined on each port pin are shown in the pin description tables in this section.

6.2.2 LQFP144 pin assignment

Table 3.	LQFP144 pin	assignment			
Symbol	Pin	Description			
		Function 0 (default)	Function 1	Function 2	Function 3
TDO	1	IEEE 1149.1 test data	out		
P2.21	2	GPIO 2, pin 21	-	PWM2 CAP1	EXTBUS D19
P0.24	3	GPIO 0, pin 24	UART1 TxD	CAN1 TxD	SPI2 SCS0
P0.25	4	GPIO 0, pin 25	UART1 RxD	CAN1 RxD	SPI2 SDO
P0.26	5	GPIO 0, pin 26	-	-	SPI2 SDI
P0.27	6	GPIO 0, pin 27	-	-	SPI2 SCK
P0.28	7	GPIO 0, pin 28	-	TIMER0 CAP0	TIMER0 MAT0
P0.29	8	GPIO 0, pin 29	-	TIMER0 CAP1	TIMER0 MAT1
V _{DD(IO)}	9	3.3 V power supply for	· I/O		
P2.22	10	GPIO 2, pin 22	-	PWM2 CAP2	EXTBUS D20
P2.23	11	GPIO 2, pin 23	-	PWM3 CAP0	EXTBUS D21
P3.6	12	GPIO 3, pin 6	SPI0 SCS3	PWM1 MAT0	LIN1 TxD
P3.7	13	GPIO 3, pin 7	SPI2 SCS1	PWM1 MAT1	LIN1 RxD
P0.30	14	GPIO 0, pin 30	-	TIMER0 CAP2	TIMER0 MAT2
P0.31	15	GPIO 0, pin 31	-	TIMER0 CAP3	TIMER0 MAT3



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Symbol	Pin	assignmentcontinued Description			Function 3
		Function 0 (default)	Function 1	Function 2	Function 3 EXTBUS D22 EXTBUS D23
P2.24	16	GPIO 2, pin 24	-	PWM3 CAP1	EXTBUS D22
P2.25	17	GPIO 2, pin 25	-	PWM3 CAP2	EXTBUS D23
V _{DD(CORE)}	18	1.8 V power supply for	digital core		
V _{SS(CORE)}	19	ground for digital core			
P1.31	20	GPIO 1, pin 31	TIMER0 CAP1	TIMER0 MAT1	EXTINT5
V _{SS(IO)}	21	ground for I/O			
P1.30	22	GPIO 1, pin 30	TIMER0 CAP0	TIMER0 MAT0	EXTINT4
P3.8	23	GPIO 3, pin 8	SPI2 SCS0	PWM1 MAT2	-
P3.9	24	GPIO 3, pin 9	SPI2 SDO	PWM1 MAT3	-
P1.29	25	GPIO 1, pin 29	TIMER1 CAP0, EXT START	PWM TRAP0	PWM3 MAT5
P1.28	26	GPIO 1, pin 28	TIMER1 CAP1, ADC1 EXT START	PWM TRAP1	PWM3 MAT4
P2.26	27	GPIO 2, pin 26	TIMER0 CAP2	TIMER0 MAT2	EXTINT6
P2.27	28	GPIO 2, pin 27	TIMER0 CAP3	TIMER0 MAT3	EXTINT7
P1.27	29	GPIO 1, pin 27	TIMER1 CAP2, ADC2 EXT START	PWM TRAP2	PWM3 MAT3
P1.26	30	GPIO 1, pin 26	PWM2 MAT0	PWM TRAP3	PWM3 MAT2
V _{DD(IO)}	31	3.3 V power supply for	I/O		
P1.25	32	GPIO 1, pin 25	PWM1 MAT0	-	PWM3 MAT1
P1.24	33	GPIO 1, pin 24	PWM0 MAT0	-	PWM3 MAT0
P1.23	34	GPIO 1, pin 23	UART0 RxD	-	EXTBUS CS5
P1.22	35	GPIO 1, pin 22	UART0 TxD	-	EXTBUS CS4
TMS	36	IEEE 1149.1 test mode	e select, pulled up intern	ally.	
ГСК	37	IEEE 1149.1 test clock			
P1.21	38	GPIO 1, pin 21	TIMER3 CAP3	TIMER1 CAP3, MSCSS PAUSE	EXTBUS D7
P1.20	39	GPIO 1, pin 20	TIMER3 CAP2	SPI0 SCS1	EXTBUS D6
P1.19	40	GPIO 1, pin 19	TIMER3 CAP1	SPI0 SCS2	EXTBUS D5
P1.18	41	GPIO 1, pin 18	TIMER3 CAP0	SPI0 SDO	EXTBUS D4
P1.17	42	GPIO 1, pin 17	TIMER2 CAP3	SPI0 SDI	EXTBUS D3
/ _{SS(IO)}	43	ground for I/O			
P1.16	44	GPIO 1, pin 16	TIMER2 CAP2	SPI0 SCK	EXTBUS D2
P2.0	45	GPIO 2, pin 0	TIMER2 MAT0	PWM TRAP3	EXTBUS D8
P2.1	46	GPIO 2, pin 1	TIMER2 MAT1	PWM TRAP2	EXTBUS D9
P3.10	47	GPIO 3, pin 10	SPI2 SDI	PWM1 MAT4	-
P3.11	48	GPIO 3, pin 11	SPI2 SCK	PWM1 MAT5	-
P1.15	49	GPIO 1, pin 15	TIMER2 CAP1	SPI0 SCS0	EXTBUS D1
P1.14	50	GPIO 1, pin 14	TIMER2 CAP0	SPI0 SCS3	EXTBUS D0
P1.13	51	GPIO 1, pin 13	EXTINT3	-	EXTBUS WEN
P1.12	52	GPIO 1, pin 12	EXTINT2	-	EXTBUS OEN

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able 3. LQFF	P144 pin a	assignmentcontinued			troller with CAN and LIN
Symbol	Pin	Description			
		Function 0 (default)) Function 1	Function 2	Function 3
DD(IO)	53	3.3 V power supply for	or I/O	·	EXTBUS D10
2.2	54	GPIO 2, pin 2	TIMER2 MAT2	PWM TRAP1	EXTBUS D10
2.3	55	GPIO 2, pin 3	TIMER2 MAT3	PWM TRAP0	EXTBUS D11
1.11	56	GPIO 1, pin 11	SPI1 SCK	-	EXTBUS CS3
1.10	57	GPIO 1, pin 10	SPI1 SDI	-	EXTBUS CS2
3.12	58	GPIO 3, pin 12	SPI1 SCS0	EXTINT4	-
SS(CORE)	59	ground for digital core	Э		
DD(CORE)	60	1.8 V power supply for	or digital core		
3.13	61	GPIO 3, pin 13	SPI1 SDO	EXTINT5	-
2.4	62	GPIO 2, pin 4	TIMER1 MAT0	EXTINT0	EXTBUS D12
2.5	63	GPIO 2, pin 5	TIMER1 MAT1	EXTINT1	EXTBUS D13
1.9	64	GPIO 1, pin 9	SPI1 SDO	LIN1 RxD	EXTBUS CS1
SS(IO)	65	ground for I/O			
1.8	66	GPIO 1, pin 8	SPI1 SCS0	LIN1 TxD	EXTBUS CS0
1.7	67	GPIO 1, pin 7	SPI1 SCS3	UART1 RxD	EXTBUS A7
.6	68	GPIO 1, pin 6	SPI1 SCS2	UART1 TxD	EXTBUS A6
6	69	GPIO 2, pin 6	TIMER1 MAT2	EXTINT2	EXTBUS D14
.5	70	GPIO 1, pin 5	SPI1 SCS1	PWM3 MAT5	EXTBUS A5
1.4	71	GPIO 1, pin 4	SPI2 SCS2	PWM3 MAT4	EXTBUS A4
RSTN	72	IEEE 1149.1 test rese	et NOT; active LOW; p	ulled up internally	
STN	73	asynchronous device	reset; active LOW; pu	Illed up internally	
SS(OSC)	74	ground for oscillator			
OUT_OSC	75	crystal out for oscillat	or		
N_OSC	76	crystal in for oscillato	r		
DD(OSC)	77	1.8 V supply for oscil	lator		
SS(PLL)	78	ground for PLL			
2.7	79	GPIO 2, pin 7	TIMER1 MAT3	EXTINT3	EXTBUS D15
3.14	80	GPIO 3, pin 14	SPI1 SDI	EXTINT6	CAN0 TxD
3.15	81	GPIO 3, pin 15	SPI1 SCK	EXTINT7	CAN0 RxD
DD(IO)	82	3.3 V power supply for	or I/O		
2.8	83	GPIO 2, pin 8	-	PWM0 MAT0	SPI0 SCS2
2.9	84	GPIO 2, pin 9	-	PWM0 MAT1	SPI0 SCS1
1.3	85	GPIO 1, pin 3	SPI2 SCS1	PWM3 MAT3	EXTBUS A3
.2	86	GPIO 1, pin 2	SPI2 SCS3	PWM3 MAT2	EXTBUS A2
.1	87	GPIO 1, pin 1	EXTINT1	PWM3 MAT1	EXTBUS A1
SS(CORE)	88	ground for digital core			
D(CORE)	89	1.8 V power supply for			
I.0	90	GPIO 1, pin 0	EXTINT0	PWM3 MAT0	EXTBUS A0
2.10	91	GPIO 2, pin 10	-	PWM0 MAT2	SPI0 SCS0
2.11	92	GPIO 2, pin 10		PWM0 MAT3	SPI0 SCK

LOEP144 nin assignment Table 3

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Symbol	Pin	Description						
		Function 0 (default)	Function 1	Function 2	Function 3 EXTBUS D24 EXTBUS D25 EXTBUS D26			
P0.0	93	GPIO 0, pin 0	-	CAN0 TxD	EXTBUS D24			
/ _{SS(IO)}	94	ground for I/O						
P0.1	95	GPIO 0, pin 1	-	CAN0 RxD	EXTBUS D25			
P0.2	96	GPIO 0, pin 2	-	PWM0 MAT0	EXTBUS D26			
P0.3	97	GPIO 0, pin 3	-	PWM0 MAT1	EXTBUS D27			
P3.0	98	GPIO 3, pin 0	-	PWM2 MAT0	EXTBUS CS6			
P3.1	99	GPIO 3, pin 1	-	PWM2 MAT1	EXTBUS CS7			
P2.12	100	GPIO 2, pin 12	-	PWM0 MAT4	SPI0 SDI			
P2.13	101	GPIO 2, pin 13	-	PWM0 MAT5	SPI0 SDO			
P0.4	102	GPIO 0, pin 4	-	PWM0 MAT2	EXTBUS D28			
P0.5	103	GPIO 0, pin 5	-	PWM0 MAT3	EXTBUS D29			
/ _{DD(IO)}	104	3.3 V power supply for	· I/O					
P0.6	105	GPIO 0, pin 6	-	PWM0 MAT4	EXTBUS D30			
P0.7	106	GPIO 0, pin 7	-	PWM0 MAT5	EXTBUS D31			
DD(A3V3)	107	3.3 V power supply for	AD Converters					
TAGSEL	108		TAP controller select input; LOW-level selects the ARM debug mode; HIGH-level selects boundary scan and flash programming; pulled up internally					
IC	109	-						
REFP	110	HIGH reference for AD	HIGH reference for AD Converters					
REFN	111	LOW reference for AD	Converters					
0.8	112	GPIO 0, pin 8	ADC1 IN0	LIN0 TxD	EXTBUS A20			
0.9	113	GPIO 0, pin 9	ADC1 IN1	LIN0 RxD	EXTBUS A21			
0.10	114	GPIO 0, pin 10	ADC1 IN2	PWM1 MAT0	EXTBUS A8			
0.11	115	GPIO 0, pin 11	ADC1 IN3	PWM1 MAT1	EXTBUS A9			
2.14	116	GPIO 2, pin 14	-	PWM0 CAP0	EXTBUS BLS0			
2.15	117	GPIO 2, pin 15	-	PWM0 CAP1	EXTBUS BLS1			
93.2	118	GPIO 3, pin 2	TIMER3 MAT0	PWM2 MAT2	-			
/ _{SS(IO)}	119	ground for I/O						
P3.3	120	GPIO 3, pin 3	TIMER3 MAT1	PWM2 MAT3	-			
P0.12	121	GPIO 0, pin 12	ADC1 IN4	PWM1 MAT2	EXTBUS A10			
P0.13	122	GPIO 0, pin 13	ADC1 IN5	PWM1 MAT3	EXTBUS A11			
0.14	123	GPIO 0, pin 14	ADC1 IN6	PWM1 MAT4	EXTBUS A12			
0.15	124	GPIO 0, pin 15	ADC1 IN7	PWM1 MAT5	EXTBUS A13			
0.16	125	GPIO 0, pin 16	ADC2 IN0	UART0 TXD	EXTBUS A22			
0.17	126	GPIO 0, pin 17	ADC2 IN1	UART0 RXD	EXTBUS A23			
DD(CORE)	127	1.8 V power supply for						
SS(CORE)	128	ground for digital core						
2.16	129	GPIO 2, pin 16	UART1 TxD	PWM0 CAP2	EXTBUS BLS2			
	-	· · · ·			-			

		ARM9 microcontroller with CAN		
LQFP144 pin a	assignmentcontinued			
Pin	Description			
	Function 0 (default)	Function 1	Function 2	Function 3
132	GPIO 0, pin 18	ADC2 IN2	PWM2 MAT0	EXTBUS A14
133	GPIO 0, pin 19	ADC2 IN3	PWM2 MAT1	EXTBUS A15
134	GPIO 3, pin 4	TIMER3 MAT2	PWM2 MAT4	CAN1 TxD
135	GPIO 3, pin 5	TIMER3 MAT3	PWM2 MAT5	CAN1 RxD
136	GPIO 2, pin 18	-	PWM1 CAP1	EXTBUS D16
137	GPIO 2, pin 19	-	PWM1 CAP2	EXTBUS D17
138	GPIO 0, pin 20	ADC2 IN4	PWM2 MAT2	EXTBUS A16
139	GPIO 0, pin 21	ADC2 IN5	PWM2 MAT3	EXTBUS A17
140	GPIO 0, pin 22	ADC2 IN6	PWM2 MAT4	EXTBUS A18
141	ground for I/O			
142	GPIO 0, pin 23	ADC2 IN7	PWM2 MAT5	EXTBUS A19
143	GPIO 2, pin 20	-	PWM2 CAP0	EXTBUS D18
144	IEEE 1149.1 data in, p	ulled up internally.		
	Pin 132 133 134 135 136 137 138 139 140 141 142 143	Function 0 (default) 132 GPIO 0, pin 18 133 GPIO 0, pin 19 134 GPIO 3, pin 4 135 GPIO 3, pin 5 136 GPIO 2, pin 18 137 GPIO 2, pin 19 138 GPIO 0, pin 20 139 GPIO 0, pin 21 140 GPIO 0, pin 22 141 ground for I/O 142 GPIO 2, pin 20	Pin Description Function 0 (default) Function 1 132 GPIO 0, pin 18 ADC2 IN2 133 GPIO 0, pin 19 ADC2 IN3 134 GPIO 3, pin 4 TIMER3 MAT2 135 GPIO 2, pin 18 - 136 GPIO 2, pin 18 - 137 GPIO 2, pin 19 - 138 GPIO 0, pin 20 ADC2 IN4 139 GPIO 0, pin 21 ADC2 IN5 140 GPIO 0, pin 23 ADC2 IN6 141 ground for I/O - 143 GPIO 2, pin 20 -	LQFP144 pin assignmentcontinuedPinDescriptionFunction 1Function 2132GPIO 0, pin 18ADC2 IN2PWM2 MAT0133GPIO 0, pin 19ADC2 IN3PWM2 MAT1134GPIO 3, pin 4TIMER3 MAT2PWM2 MAT4135GPIO 3, pin 5TIMER3 MAT3PWM2 MAT5136GPIO 2, pin 18-PWM1 CAP1137GPIO 2, pin 19-PWM1 CAP2138GPIO 0, pin 20ADC2 IN4PWM2 MAT3139GPIO 0, pin 21ADC2 IN5PWM2 MAT4140GPIO 0, pin 22ADC2 IN6PWM2 MAT4141ground for I/O-PWM2 MAT5143GPIO 0, pin 23ADC2 IN7PWM2 MAT5

EP144 pip assignment abla 2

7. Functional description

7.1 Reset, debug, test and power description

7.1.1 Reset and power-up behavior

The LPC2917/19 contains external reset input and internal power-up reset circuits. This ensures that a reset is extended internally until the oscillators and flash have reached a stable state. See Section 11 for trip levels of the internal power-up reset circuit¹. See Section 12 for characteristics of the several start-up and initialization times. Table 4 shows the reset pin.

Table 4. Reset pin

Symbol	Direction	Description
RSTN	in	external reset input, active LOW; pulled up internally

At activation of the RSTN pin the JTAGSEL pin is sensed as logic LOW. If this is the case the LPC2917/19 is assumed to be connected to debug hardware, and internal circuits re-program the source for the BASE_SYS_CLK to be the crystal oscillator instead of the Low-Power Ring Oscillator (LP_OSC). This is required because the clock rate when running at LP_OSC speed is too low for the external debugging environment.

7.1.2 Reset strategy

The LPC2917/19 contains a central module, the Reset Generator Unit (RGU) in the Power, Clock and Reset Control Subsystem (PCRSS), which controls all internal reset signals towards the peripheral modules. The RGU provides individual reset control as well as the monitoring functions needed for tracing a reset back to source.

^{1.} Only for 1.8 V power sources

7.1.3 IEEE 1149.1 interface pins (JTAG boundary-scan test)

DRAFT DRAF The LPC2917/19 contains boundary-scan test logic according to IEEE 1149.1, also referred to in this document as Joint Test Action Group (JTAG). The boundary-scan test pins can be used to connect a debugger probe for the embedded ARM processor. Pin-JTAGSEL selects between boundary-scan mode and debug mode. Table 5 shows the boundary- scan test pins.

Table 5.	IEEE 1149.1 boundary-scan test and debug interface
Symbol	Description
JTAGSEL	TAP controller select input. LOW level selects ARM debug mode and HIGH level selects boundary scan and flash programming; pulled up internally
TRSTN	test reset input; pulled up internally (active LOW)
TMS	test-mode select input; pulled up internally
TDI	test data input, pulled up internally
TDO	test data output
ТСК	test clock input

7.1.4 Power supply pins description

Table 6 shows the power supply pins.

Table 6.	Power supplies
Symbol	Description
$V_{\text{DD}(\text{CORE})}$	digital core supply 1.8 V
$V_{SS(CORE)}$	digital core ground (digital core, ADC 1)
V _{DD(IO)}	I/O pins supply 3.3 V
V _{SS(IO)}	I/O pins ground
V _{DD(OSC)}	oscillator and PLL supply
V _{SS(OSC)}	oscillator ground
V _{DD(A3V3)}	ADC 3.3 V supply
V _{SS(PLL)}	PLL ground

7.2 Clocking strategy

7.2.1 Clock architecture

The LPC2917/19 contains several different internal clock areas. Peripherals like Timers, SPI, UART, CAN and LIN have their own individual clock sources called Base Clocks. All base clocks are generated by the Clock Generator Unit (CGU). They may be unrelated in frequency and phase and can have different clock sources within the CGU.

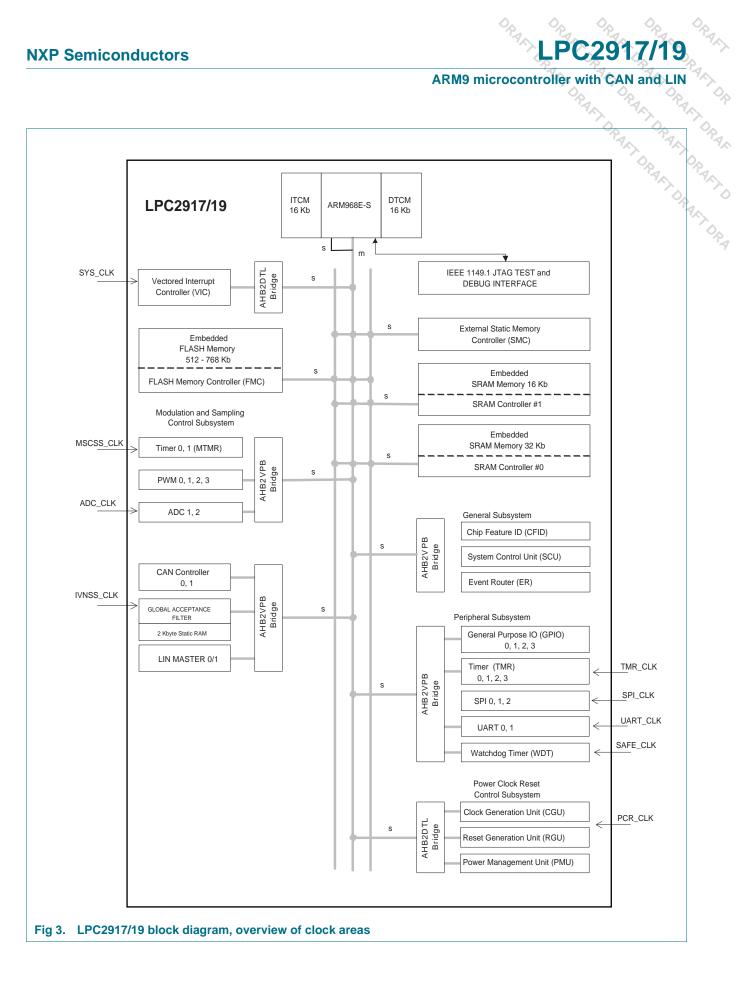
The system clock for the CPU and AHB Multilayer Bus infrastructure has its own base clock. This means most peripherals are clocked independently from the system clock. See Figure 3 for an overview of the clock areas within the device.

Within each clock area there may be multiple branch clocks, which offers very flexible control for power-management purposes. All branch clocks are outputs of the Power Management Unit (PMU) and can be controlled independently. Branch clocks derived from the same base clock are synchronous in frequency and phase. See Section 8.8 for more details of clock and power control within the device.

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7.2.2 Base clock and branch clock relationship

The next table contains an overview of all the base blocks in the LPC2917/19 and their derived branch clocks. A short description is given of the hardware parts that are clocked with the individual branch clocks. In relevant cases more detailed information can be found in the specific subsystem description. Some branch clocks have special protection since they clock vital system parts of the device and should (for example) not be switched off. See Section 8.8.6 for more details of how to control the individual branch clocks.

Table 7. Base clock and branch clock overview

Base clock	Branch clock name	Parts of the device clocked by this branch clock	Remark
BASE_SAFE_CLK	CLK_SAFE	Watchdog Timer	<u>[1]</u>
BASE_SYS_CLK	CLK_SYS_CPU	ARM968E-S and TCMs	
	CLK_SYS_SYS	AHB Bus infrastructure	
	CLK_SYS_PCRSS	AHB side of bridge in PCRSS	
	CLK_SYS_FMC	Flash-Memory Controller	
	CLK_SYS_RAM0	Embedded SRAM Controller 0 (32 KByte)	
	CLK_SYS_RAM1	Embedded SRAM Controller 1 (16 KByte)	
	CLK_SYS_SMC	External Static-Memory Controller	
	CLK_SYS_GESS	General Subsystem	
	CLK_SYS_VIC	Vectored Interrupt Controller	
	CLK_SYS_PESS	Peripheral Subsystem	[2] [4]
	CLK_SYS_GPIO0	GPIO bank 0	
	CLK_SYS_GPIO1	GPIO bank 1	
	CLK_SYS_GPIO2	GPIO bank 2	
	CLK_SYS_GPIO3	GPIO bank 3	
	CLK_SYS_IVNSS_A	AHB side of bridge of IVNSS	
BASE_PCR_CLK	CLK_PCR_SLOW	PCRSS, CGU, RGU and PMU logic clock	<u>[1]</u> , <u>[3]</u>
BASE_IVNSS_CLK	CLK_IVNSS_VPB	VPB side of the IVNSS	
	CLK_IVNSS_CANCA	CAN controller Acceptance Filter	
	CLK_IVNSS_CANC0	CAN channel 0	
	CLK_IVNSS_CANC1	CAN channel 1	
	CLK_IVNSS_LIN0	LIN channel 0	
	CLK_IVNSS_LIN1	LIN channel 1	



able 7. Base clock and	d branch clock overview	continued	Op
Base clock	Branch clock name	Parts of the device clocked by this branch clock	Remark
BASE_MSCSS_CLK	CLK_MSCSS_VPB	VPB side of the MSCSS	
	CLK_MSCSS_MTMR0	Timer 0 in the MSCSS	
	CLK_MSCSS_MTMR1	Timer 1 in the MSCSS	147 D
	CLK_MSCSS_PWM0	PWM 0	
	CLK_MSCSS_PWM1	PWM 0	
	CLK_MSCSS_PWM2	PWM 0	
	CLK_MSCSS_PWM3	PWM 0	
	CLK_MSCSS_ADC1_V PB	VPB side of ADC 1	
	CLK_MSCSS_ADC2_V PB	VPB side of ADC 2	
BASE_UART_CLK	CLK_UART0	UART 0 interface clock	
	CLK_UART1	UART 1 interface clock	
BASE_SPI_CLK	CLK_SPI0	SPI 0 interface clock	
	CLK_SPI1	SPI 1 interface clock	
	CLK_SPI2	SPI 2 interface clock	
BASE_TMR_CLK	CLK_TMR0	Timer 0 clock for counter part	
	CLK_TMR1	Timer 1 clock for counter part	
	CLK_TMR2	Timer 2 clock for counter part	
	CLK_TMR3	Timer 3 clock for counter part	
BASE_ADC_CLK	CLK_ADC1	Control of ADC 1, capture sample result	
	CLK_ADC2	Control of ADC 2, capture sample result	
BASE_CLK_TESTSHELL	CLK_TESTSHELL_IP		

Table 7. Base clock and branch clock overview ... continued

[1] This clock is always on (cannot be switched off for system safety reasons)

[2] In the peripheral subsystem parts of the Timers, Watchdog Timer, SPI and UART have their own clock source. See Section 8.4 for details.

- [3] In the Power Clock and Reset Control subsystem parts of the CGU, RGU PMU have their own clock source. See Section 8.8 for details.
- [4] The clock should remain activated when system wake-up on timer or UART is required.

Block description 8.

8.1 Flash memory controller

8.1.1 Overview

The Flash Memory Controller (FMC) interfaces to the embedded flash memory for two tasks:

- Providing memory data transfer
- Memory configuration via triggering, programming and erasing

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The flash memory has a 128-bit wide data interface and the flash controller offers two 128-bit buffer lines to improve system performance. The flash has to be programmed initially via JTAG. In-system programming must be supported by the boot loader. In-application programming is possible. Flash memory contents can be protected by disabling JTAG access. Suspension of burning or erasing is not supported.

The key features are:

- Programming by CPU via AHB
- Programming by external programmer via JTAG
- JTAG access protection
- Burn-finished and erase-finished interrupt

8.1.2 Description

After reset flash initialization is started, which takes t_{init} time, see <u>Section 12</u>. During this initialization flash access is not possible and AHB transfers to flash are stalled, blocking the AHB bus.

During flash initialization the index sector is read to identify the status of the JTAG access protection and sector security. If JTAG access protection is active the flash is not accessible via JTAG. ARM debug facilities are disabled to protect the flash-memory contents against unwanted reading out externally. If sector security is active only the concerned sections are read.

Flash can be read synchronously or asynchronously to the system clock. In synchronous operation the flash goes into standby after returning the read data. Started reads cannot be stopped, and speculative reading and dual buffering are therefore not supported.

With asynchronous reading, transfer of the address to the flash and of read data from the flash is done asynchronously, giving the fastest possible response time. Started reads can be stopped, so speculative reading and dual buffering are supported.

Buffering is offered because the flash has a 128-bit wide data interface while the AHB interface has only 32 bits. With buffering a buffer line holds the complete 128-bit flash word, from which four words can be read. Without buffering every AHB data port read starts a flash read. A flash read is a slow process compared to the minimum AHB cycle time, so with buffering the average read time is reduced. This can improve system performance.

With single buffering the most recently read flash word remains available until the next flash read. When an AHB data-port read transfer requires data from the same flash word as the previous read transfer, no new flash read is done and the read data is given without wait cycles.

When an AHB data-port read transfer requires data from a different flash word to that involved in the previous read transfer, a new flash read is done and wait states are given until the new read data is available.

With dual buffering a secondary buffer line is used, the output of the flash being considered as the primary buffer. On a primary buffer hit data can be copied to the secondary buffer line, which allows the flash to start a speculative read of the next flash word.

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Both buffer lines are invalidated after:

- Initialization
- Configuration-register access
- Data-latch reading
- Index-sector reading

The modes of operation are listed in Table 8.

Synchronous timing		
No buffer line	for single (non-linear) reads; one flash-word read per word read	
Single buffer line	default mode of operation; most recently read flash word is kept until another flash word is required	
Asynchronous timing		
No buffer line	one flash-word read per word read	
Single buffer line	most recently read flash word is kept until another flash word is required	
Dual buffer line, single speculative	on a buffer miss a flash read is done, followed by at most one speculative read; optimized for execution of code with small loops (less than eight words) from flash	
Dual buffer line, always speculative	most recently used flash word is copied into second buffer line; next flash-word read is started; highest performance for linear reads	

8.1.3 Flash memory controller pin description

The flash memory controller has no external pins. However, the flash can be programmed via the JTAG pins, see <u>Section 7.1.3</u>.

8.1.4 Flash memory controller clock description

The flash memory controller is clocked by CLK_SYS_FMC, see Section 7.2.2.

8.1.5 Flash layout

The ARM processor can program the flash for ISP (In-System Programming) and IAP (In-Application Programming). Note that the flash always has to be programmed by 'flash words' of 128 bits (four 32-bit AHB bus words, hence 16 bytes).

The flash memory is organized into eight 'small' sectors of 8 kB each and up to 11 'large' sectors of 64 kB each. The number of large sectors depends on the device type. A sector must be erased before data can be written to it. The flash memory also has sector-wise protection. Writing occurs per page which consists of 4096 bits (32 flash words). A small sector contains 16 pages; a large sector contains 128 pages.

Table 9 gives an overview of the flash-sector base addresses.

Table 9.Flash sector overview

Sector number	Sector size (kB)	Sector base address
0	8	0000 0000h
1	8	0000 2000h
2	8	0000 4000h

Table 9.	Flash secto	or overviewcontinued		Op	Op	Op.
Sector nu	umber	Sector size (kB)	Sector base address			, 'Y
3		8	0000 6000h		PAN	PAN
4		8	0000 8000h		~~>	PAR.
5		8	0000 A000h			Ar.
6		8	0000 C000h			0
7		8	0000 E000h			- 5
8		64	0001 0000h			
9		64	0002 0000h			
10		64	0003 0000h			
11		64	0004 0000h			
12		64	0005 0000h			
13		64	0006 0000h			
14		64	0007 0000h			
15 <mark>11</mark>		64	0008 0000h			
16 <mark>[1]</mark>		64	0009 0000h			
17 <mark>[1]</mark>		64	000A 0000h			
18 <mark>[1]</mark>		64	000B 0000h			_

[1] Availability of sector 15 to sector 18 depends on device type, see Section 4 "Ordering information".

The index sector is a special sector in which the JTAG access protection and sector security are located. The address space becomes visible by setting the FS_ISS bit and overlaps the regular flash sector's address space.

Note that the index sector cannot be erased, and that access to it has to be performed via code outside the flash.

8.1.6 Flash bridge wait-states

To eliminate the delay associated with synchronizing flash-read data, a predefined number of wait-states must be programmed. These depend on flash-memory response time and system clock period. The minimum wait-states value can be calculated with the following formulas:

Synchronous reading:

$$WST > \frac{t_{acc(clk)}}{t_{t_{tclk(sys)}}} - 1$$

Asynchronous reading:

$$WST > \frac{t_{acc(addr)}}{t_{tclk(sys)}} - 1$$

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Remark: If the programmed number of wait-states is more than three, flash-data reading cannot be performed at full speed (i.e. with zero wait-states at the AHB bus) if speculative reading is active.

8.2 External static memory controller

8.2.1 Overview

The LPC2917/19 contains an external Static Memory Controller (SMC) which provides an interface for external (off-chip) memory devices.

Key features are:

- Supports static memory-mapped devices including RAM, ROM, flash, burst ROM and external I/O devices
- Asynchronous page-mode read operation in non-clocked memory subsystems
- Asynchronous burst-mode read access to burst-mode ROM devices
- Independent configuration for up to eight banks, each up to 16 MB
- Programmable bus-turnaround (idle) cycles (one to 16)
- Programmable read and write wait states (up to 32), for static RAM devices
- Programmable initial and subsequent burst-read wait state for burst-ROM devices
- Programmable write protection
- Programmable burst-mode operation
- Programmable external data width: 8-bit, 16-bit or 32-bit
- Programmable read-byte lane enable control

8.2.2 Description

The SMC simultaneously supports up to eight independently configurable memory banks. Each memory bank can be 8, 16 or 32 bits wide and is capable of supporting SRAM, ROM, burst-ROM memory or external I/O devices.

A separate chip-select output is available for each bank. The chip-select lines are configurable to be active HIGH or LOW. Memory-bank selection is controlled by memory addressing. <u>Table 10</u> shows how the 32-bit system address is mapped to the external bus memory base addresses, chip selects and bank internal addresses.

Table 10.	External	memory-bank address bit description
-----------	----------	-------------------------------------

32 bit System Address Bit field	Symbol	Description
31 to 29	BA[2:0]	external static-memory base address (three most significant bits); the base address can be found in the memory map; see <u>Ref. 1</u> . This field contains '010' when addressing an external memory bank.
28 to 26	CS[2:0]	chip-select address space for eight memory banks; see [1]
25 and 24	-	always '00'; other values are 'mirrors' of the 16 MByte bank address
23 to 0	A[23:0]	16-MByte memory banks address space

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Table 11.	External static-memory controller banks	Op Op Op
CS[2:0]	Bank	
000	bank 0	RAC RAS
001	bank 1	
010	bank 2	AV.
011	bank 3	(Op
100	bank 4	
101	bank 5	
110	bank 6	
111	bank 7	

8.2.3 External static-memory controller pin description

The external static-memory controller module in the LPC2917/19 has the following pins, which are combined with other functions on the port pins of the LPC2917/19. <u>Table 12</u> shows the external memory controller pins.

Table 12. External memory controller pins

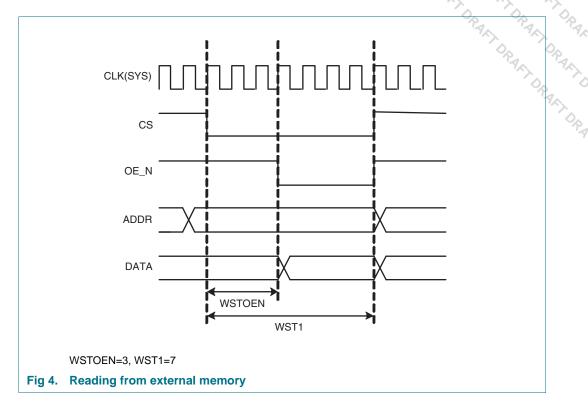
SymbolDirectionDescriptionEXTBUS CSxoutmemory-bank x select, x runs from 0 to 7EXTBUS BLSyoutbyte-lane select input y, y runs from 0 to 3EXTBUS WE_Noutwrite enable (active LOW)EXTBUS OE_Noutoutput enable (active LOW)EXTBUS A[23:0]outaddress busEXTBUS D[31:0]in/outdata bus			
EXTBUS BLSyoutbyte-lane select input y, y runs from 0 to 3EXTBUS WE_Noutwrite enable (active LOW)EXTBUS OE_Noutoutput enable (active LOW)EXTBUS A[23:0]outaddress bus	Symbol	Direction	Description
EXTBUS WE_Noutwrite enable (active LOW)EXTBUS OE_Noutoutput enable (active LOW)EXTBUS A[23:0]outaddress bus	EXTBUS CSx	out	memory-bank x select, x runs from 0 to 7
EXTBUS OE_N out output enable (active LOW) EXTBUS A[23:0] out address bus	EXTBUS BLSy	out	byte-lane select input y, y runs from 0 to 3
EXTBUS A[23:0] out address bus	EXTBUS WE_N	out	write enable (active LOW)
	EXTBUS OE_N	out	output enable (active LOW)
EXTBUS D[31:0] in/out data bus	EXTBUS A[23:0]	out	address bus
	EXTBUS D[31:0]	in/out	data bus

8.2.4 External static-memory controller clock description

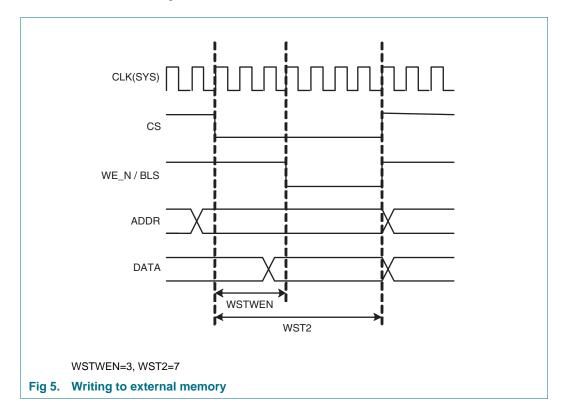
The External Static-Memory Controller is clocked by CLK_SYS_SMC, see Section 7.2.2.

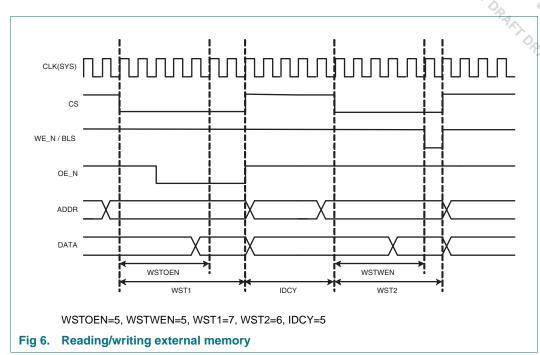
8.2.5 External memory timing diagrams

A timing diagram for reading from external memory is shown in <u>Figure 4</u>. The relationship between the wait-state settings is indicated with arrows.



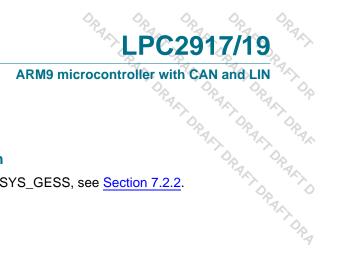
A timing diagram for writing to external memory is shown In <u>Figure 5</u>. The relationship between wait-state settings is indicated with arrows.





Usage of the idle/turn-around time (IDCY) is demonstrated In Figure 6. Extra wait states are added between a read and a write cycle in the same external memory device.

Address pins on the device are shared with other functions. When connecting external memories, check that the I/O pin is programmed for the correct function. Control of these settings is handled by the SCU.



8.3 General subsystem

8.3.1 General subsystem clock description

The general subsystem is clocked by CLK_SYS_GESS, see Section 7.2.2.

8.3.2 Chip and feature identification

8.3.2.1 Overview

The key features are:

- Identification of product
- Identification of features enabled

8.3.2.2 Description

The Chip/Feature ID (CFID) module contains registers which show and control the functionality of the chip. It contains an ID to identify the silicon, and also registers containing information about the features enabled or disabled on the chip.

8.3.2.3 CFID pin description

The CFID has no external pins.

8.3.3 System Control Unit (SCU)

8.3.3.1 Overview

The system control unit takes care of system-related functions. The key feature is configuration of the I/O port-pins multiplexer.

8.3.3.2 Description

The system control unit defines the function of each I/O pin of the LPC2917/19. The I/O pin configuration should be consistent with peripheral function usage.

8.3.3.3 SCU pin description

The SCU has no external pins.

8.3.4 Event router

8.3.4.1 Overview

The event router provides bus-controlled routing of input events to the vectored interrupt controller for use as interrupt or wake-up signals.

Key features:

- Up to 24 level-sensitive external interrupt pins, including CAN, LIN and RxD wake-up features plus three internal event sources
- Input events can be used as interrupt source either directly or latched (edge-detected)
- Direct events disappear when the event becomes inactive
- Latched events remain active until they are explicitly cleared
- · Programmable input level and edge polarity
- Event detection maskable

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· Event detection is fully asynchronous, so no clock is required

8.3.4.2 Description

AN an Description The event router allows the event source to be defined, its polarity and activation type to be selected and the interrupt to be masked or enabled. The event router can be used to the selected and the interrupt to be masked or enabled. The event router can be used to the selected and the interrupt to be masked or enabled.

The vectored interrupt-controller inputs are active HIGH.

8.3.4.3 Event-router pin description and mapping to register bit positions

The event router module in the LPC2917/19 is connected to the pins listed below. The pins are combined with other functions on the port pins of the LPC2917/19. Table 13 shows the pins connected to the event router, and also the corresponding bit position in the event-router registers and the default polarity.

Symbol	Direction	Bit position	Description	Default polarity
EXTINT0	in	0	external interrupt input 0	1
EXTINT1	in	1	external interrupt input 1	1
EXTINT2	in	2	external interrupt input 2	1
EXTINT3	in	3	external interrupt input 3	1
EXTINT4	in	4	external interrupt input 4	1
EXTINT5	in	5	external interrupt input 5	1
EXTINT6	in	6	external interrupt input 6	1
EXTINT7	in	7	external interrupt input 7	1
CAN0 RXD	in	8	CAN0 receive data input wake-up	0
CAN1 RXD	in	9	CAN1 receive data input wake-up	0
-	-	13 - 10	reserved	-
LIN0 RXD	in	14	LIN0 receive data input wake-up	0
LIN1 RXD	in	15	LIN1 receive data input wake-up	0
-	-	21 - 16	reserved	-
-	na	22	CAN interrupt (internal)	1
-	na	23	VIC FIQ (internal)	1
-	na	24	VIC IRQ (internal)	1
-	-	26 - 25	reserved	-

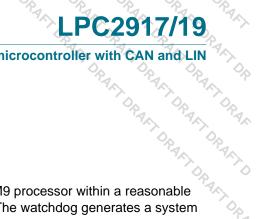
Table 13. Event-router pin connections

8.4 Peripheral subsystem

8.4.1 Peripheral subsystem clock description

The peripheral subsystem is clocked by a number of different clocks:

- CLK SYS PESS
- CLK_UART0/1
- CLK_SPI0/1/2
- CLK TMR0/1/2/3



CLK_SAFE see Section 7.2.2

8.4.2 Watchdog timer

8.4.2.1 **Overview**

The purpose of the watchdog timer is to reset the ARM9 processor within a reasonable amount of time if the processor enters an error state. The watchdog generates a system reset if the user program fails to trigger it correctly within a predetermined amount of time.

Key features:

- Internal chip reset if not periodically triggered
- Timer counter register runs on always-on safe clock
- Optional interrupt generation on watchdog timeout
- Debug mode with disabling of reset
- Watchdog control register change-protected with key
- Programmable 32-bit watchdog timer period with programmable 32-bit prescaler.

8.4.2.2 Description

The watchdog timer consists of a 32-bit counter with a 32-bit prescaler.

The watchdog should be programmed with a time-out value and then periodically restarted. When the watchdog times out it generates a reset through the RGU.

To generate watchdog interrupts in watchdog debug mode the interrupt has to be enabled via the interrupt enable register. A watchdog-overflow interrupt can be cleared by writing to the clear-interrupt register.

Another way to prevent resets during debug mode is via the Pause feature of the Watchdog Timer. The watchdog is stalled when the ARM9 is in debug mode and the PAUSE_ENABLE bit in the Watchdog Timer Control register is set.

The Watchdog Reset output is fed to the Reset Generator Unit (RGU). The RGU contains a reset source register to identify the reset source when the device has gone through a reset. See Section 8.8.5.

8.4.2.3 Pin description

The watchdog has no external pins.

8.4.2.4 Watchdog timer clock description

The Watchdog Timer is clocked by two different clocks; CLK_SYS_PESS and CLK_SAFE, see Section 7.2.2. The register interface towards the system bus is clocked by CLK SYS PESS. The timer and prescale counters are clocked by CLK SAFE which is always on.

8.4.3 Timer

8.4.3.1 Overview

The LPC2917/19 contains six identical timers: four in the peripheral subsystem and two in the Modulation and Sampling Control SubSystem (MSCSS) located at different peripheral base addresses. This section describes the four timers in the peripheral subsystem. Each

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timer has four capture inputs and/or match outputs. Connection to device pins depends on the configuration programmed into the port function-select registers. The two timers located in the MSCSS have no external capture or match pins, but the memory map is identical, see <u>Section 8.7.7</u>. One of these timers has an external input for a pause function.

The key features are:

- 32-bit timer/counter with programmable 32-bit prescaler
- Up to four 32-bit capture channels per timer. These take a snapshot of the timer value when an external signal connected to the TIMERx CAPn input changes state. A capture event may also optionally generate an interrupt
- Four 32-bit match registers per timer that allow:
 - Continuous operation with optional interrupt generation on match
 - Stop timer on match with optional interrupt generation
 - Reset timer on match with optional interrupt generation
- Up to four external outputs per timer corresponding to match registers, with the following capabilities:
 - Set LOW on match
 - Set HIGH on match
 - Toggle on match
 - Do nothing on match
- Pause input pin (MSCSS timers only)

8.4.3.2 Description

The timers are designed to count cycles of the clock and optionally generate interrupts or perform other actions at specified timer values, based on four match registers. They also include capture inputs to trap the timer value when an input signal changes state, optionally generating an interrupt. The core function of the timers consists of a 32 bit 'prescale counter' triggering the 32 bit 'timer counter'. Both counters run on clock CLK_TMRx (x runs from 0 to 3) and all time references are related to the period of this clock. Note that each timer has its individual clock source within the Peripheral SubSystem. In the Modulation and Sampling SubSystem each timer also has its own individual clock source. See section <u>Section 8.8.6</u> for information on generation of these clocks.

8.4.3.3 Pin description

The four timers in the peripheral subsystem of the LPC2917/19 have the pins described below. The two timers in the modulation and sampling subsystem have no external pins except for the pause pin on MSCSS timer 1. See <u>Section 8.7.7</u> for a description of these timers and their associated pins. The timer pins are combined with other functions on the port pins of the LPC2917/19, see <u>Section 8.3.3</u>. Table <u>Table 14</u> shows the timer pins (x runs from 0 to 3).

			Op D
Table 14. Time	r pins	RA. RA.	PAN
Symbol	Direction	Description	
TIMERx CAP[0]	IN	TIMER x capture input 0	7
TIMERx CAP[1]	IN	TIMER x capture input 1	5
TIMERx CAP[2]	IN	TIMER x capture input 2	>
TIMERx CAP[3]	IN	TIMER x capture input 3	Op
TIMERx MAT[0]	OUT	TIMER x match output 0	4
TIMERx MAT[1]	OUT	TIMER x match output 1	
TIMERx MAT[2]	OUT	TIMER x match output 2	
TIMERx MAT[3]	OUT	TIMER x match output 3	

8.4.3.4 Timer clock description

The timer modules are clocked by two different clocks; CLK_SYS_PESS and CLK_TMRx (x = 0.3), see Section 7.2.2. Note that each timer has its own CLK TMRx branch clock for power management. The frequency of all these clocks is identical as they are derived from the same base clock BASE_CLK_TMR. The register interface towards the system bus is clocked by CLK_SYS_PESS. The timer and prescale counters are clocked by CLK TMRx.

8.4.4 UARTs

8.4.4.1 Overview

The LPC2917/19 contains two identical UARTs located at different peripheral base addresses. The key features are:

- 16-byte receive and transmit FIFOs
- Registers conform to industry standard 550
- Receiver FIFO trigger points at 1 byte, 4 bytes, 8 bytes and 14 bytes
- Built-in baud-rate generator

8.4.4.2 Description

The UART is commonly used to implement a serial interface such as RS232. The LPC2917/19 contains two industry-standard 550 UARTs with 16-byte transmit and receive FIFOs, but they can also be put into 450 mode without FIFOs.

8.4.4.3 UART pin description

The two UARTs in the LPC2917/19 have the following pins. The UART pins are combined with other functions on the port pins of the LPC2917/19. Table 15 shows the UART pins (x runs from 0 to 1).

Table 1	15.	UART	pins
---------	-----	------	------

Symbol	Direction	Description	
UARTx TXD	out	UART channel x transmit data output	
UARTx RXD	in	UART channel x receive data input	

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8.4.4.4 UART clock description

AN DRAKT DRAKT DRAKT The UART modules are clocked by two different clocks; CLK_SYS_PESS and CLK_UARTx (x = 0.1), see Section 7.2.2. Note that each UART has its own CLK_UARTx branch clock for power management. The frequency of all CLK UARTx clocks is identical since they are derived from the same base clock BASE_CLK_UART. The register interface towards the system bus is clocked by CLK_SYS_PESS. The baud generator is clocked by the CLK UARTx.

8.4.5 Serial peripheral interface

8.4.5.1 Overview

The LPC2917/19 contains three Serial Peripheral Interface modules (SPIs) to allow synchronous serial communication with slave or master peripherals.

The key features are:

- Master or slave operation
- · Supports up to four slaves in sequential multi-slave operation
- Supports timer-triggered operation
- Programmable clock bit rate and prescale based on SPI source clock (BASE SPI CLK), independent of system clock
- Separate transmit and receive FIFO memory buffers; 16 bits wide, 32 locations deep
- Programmable choice of interface operation: Motorola SPI or Texas Instruments Synchronous Serial Interfaces
- Programmable data-frame size from 4 to 16 bits
- Independent masking of transmit FIFO, receive FIFO and receive overrun interrupts
- Serial clock-rate master mode: fserial_clk ≤ f_{CLK(SPI)*}/2
- Serial clock-rate slave mode: fserial_clk = f_{CLK(SPI)*}/4
- Internal loopback test mode

8.4.5.2 Functional description

The SPI module is a master or slave interface for synchronous serial communication with peripheral devices that have either Motorola SPI or Texas Instruments Synchronous Serial Interfaces.

The SPI module performs serial-to-parallel conversion on data received from a peripheral device. The transmit and receive paths are buffered with FIFO memories (16 bits wide x 32 words deep). Serial data is transmitted on SPI_TxD and received on SPI_RxD.

The SPI module includes a programmable bit-rate clock divider and prescaler to generate the SPI serial clock from the input clock CLK SPIx.

The SPI module's operating mode, frame format, and word size are programmed through the SLVn_SETTINGS registers.

A single combined interrupt request SPI_INTREQ output is asserted if any of the interrupts are asserted and unmasked.

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Depending on the operating mode selected, the SPI_CS_OUT outputs operate as an active-HIGH frame synchronization output for Texas Instruments synchronous serial frame format or an active-LOW chip select for SPI.

Each data frame is between four and 16 bits long, depending on the size of words programmed, and is transmitted starting with the MSB.

There are two basic frame types that can be selected:

- Texas Instruments synchronous serial
- Motorola Serial Peripheral Interface

8.4.5.3 Modes of operation

The SPI module can operate in:

- Master mode:
 - Normal transmission mode
 - Sequential slave mode
- Slave mode

8.4.5.4 SPI pin description

The three SPI modules in the LPC2917/19 have the pins listed below. The pins are combined with other functions on the port pins of the LPC2917/19, see <u>Section 8.3.3</u>. Table 16 shows the SPI pins (x runs from 0 to 2; y runs from 0 to 3).

Table 16. SPI pins			
Symbol	Direction	Description	
SPIx SCSy	in/out	SPIx chip select ^{[1][2]}	
SPIx SCK	in/out	SPIx clock ^[1]	
SPIx SDI	in	SPIx data input	
SPIx SDO	out	SPIx data output	

[1] Direction of SPIx SCS and SPIx SCK pins depends on master or slave mode. These pins are output in master mode, input in slave mode.

[2] In slave mode there is only one chip-select input pin, SPIx SCS0. The other chip selects have no function in slave mode.

8.4.5.5 SPI clock description

The SPI modules are clocked by two different clocks; CLK_SYS_PESS and CLK_SPIx (x = 0-2), see <u>Section 7.2.2</u>. Note that each SPI has its own CLK_SPIx branch clock for power management. The frequency of all clocks CLK_SPIx is identical as they are derived from the same base clock BASE_CLK_SPI. The register interface towards the system bus is clocked by CLK_SYS_PESS. The serial-clock rate divisor is clocked by CLK_SPIx.

The SPI clock frequency can be controlled by the CGU. In master mode the SPI clock frequency (CLK_SPIx) must be set to at least twice the SPI serial clock rate on the interface. In slave mode CLK_SPIx must be set to four times the SPI serial clock rate on the interface.

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8.4.6 General-purpose I/O

8.4.6.1 Overview

AN and AN ART DRAK The LPC2917/19 contains four general-purpose I/O ports located at different peripheral base addresses. In the 144-pin package all four ports are available. All I/O pins are bi-directional, and the direction can be programmed individually. The I/O pad behavior depends on the configuration programmed in the port function-select registers.

The key features are:

- General-purpose parallel inputs and outputs
- Direction control of individual bits
- Synchronized input sampling for stable input-data values
- All I/O defaults to input at reset to avoid any possible bus conflicts

8.4.6.2 Description

The general-purpose I/O provides individual control over each bi-directional port pin. There are two registers to control I/O direction and output level. The inputs are synchronized to achieve stable read-levels.

To generate an open-drain output, set the bit in the output register to the desired value. Use the direction register to control the signal. When set to output, the output driver actively drives the value on the output: when set to input the signal floats and can be pulled up internally or externally.

8.4.6.3 GPIO pin description

The five GPIO ports in the LPC2917/19 have the pins listed below. The GPIO pins are combined with other functions on the port pins of the LPC2917/19. Table 17 shows the GPIO pins.

Table 17. GPIO pins

Symbol	Direction	Description	
GPIO0 pin[31:0]	in/out	GPIO port x pins 31 to 0	
GPIO1 pin[31:0]	in/out	GPIO port x pins 31 to 0	
GPIO2 pin[27:0]	in/out	GPIO port x pins 27 to 0	
GPIO3 pin[15:0]	in/out	GPIO port x pins 15 to 0	

8.4.6.4 GPIO clock description

The GPIO modules are clocked by several clocks, all of which are derived from BASE_SYS_CLK; CLK_SYS_PESS and CLK_SYS_GPIOx (x = 0-3), see Section 7.2.2. Note that each GPIO has its own CLK__SYS_GPIOx branch clock for power management. The frequency of all clocks CLK SYS GPIOx is identical to CLK_SYS_PESS since they are derived from the same base clock BASE_SYS_CLK.

8.5 CAN gateway

8.5.1 Overview

IOR AN and DRACT DRACT DRAC DRACT DRAC DRACT DRAC DRACT DRAC DRACT D Controller Area Network (CAN) is the definition of a high-performance communication protocol for serial data communication. The two CAN controllers in the LPC2917/19 provide a full implementation of the CAN protocol according to the CAN specification version 2.0B. The gateway concept is fully scalable with the number of CAN controllers, and always operates together with a separate powerful and flexible hardware acceptance filter.

The key features are:

- Supports 11-bit as well as 29-bit identifiers
- Double receive buffer and triple transmit buffer
- Programmable error-warning limit and error counters with read/write access
- Arbitration-lost capture and error-code capture with detailed bit position
- Single-shot transmission (i.e. no re-transmission)
- Listen-only mode (no acknowledge; no active error flags)
- Reception of 'own' messages (self-reception request)
- Full CAN mode for message reception

8.5.2 Global acceptance filter

The global acceptance filter provides look-up of received identifiers - called acceptance filtering in CAN terminology - for all the CAN controllers. It includes a CAN ID look-up table memory, in which software maintains one to five sections of identifiers. The CAN ID look-up table memory is 2 kB large (512 words, each of 32 bits). It can contain up to 1024 standard frame identifiers (SFF) or 512 extended frame identifiers (EFF) or a mixture of both types. It is also possible to define identifier groups for standard and extended message formats.

8.5.3 CAN pin description

The two CAN controllers in the LPC2917/19 have the pins listed below. The CAN pins are combined with other functions on the port pins of the LPC2917/19. Table 18 shows the CAN pins (x runs from 0 to 1).

Table 18. CAN pins

Symbol	Direction	Description	
CANx TXDC	out	CAN channel x transmit data output	
CANx RXDC	in	CAN channel x receive data input	

8.6 LIN

8.6.1 Overview

The LPC2917/19 contain two LIN 2.0 master controllers. These can be used as dedicated LIN 2.0 master controllers with additional support for sync break generation and with hardware implementation of the LIN protocol according to spec 2.0.

The key features are:

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- Complete LIN 2.0 message handling and transfer
- One interrupt per LIN message
- Slave response time-out detection
- Programmable sync-break length
- Automatic sync-field and sync-break generation
- Programmable inter-byte space
- Hardware or software parity generation
- Automatic checksum generation
- Fault confinement
- Fractional baud-rate generator

8.6.2 LIN pin description

The two LIN 2.0 master controllers in the LPC2917/19 have the pins listed below. The LIN pins are combined with other functions on the port pins of the LPC2917/19. <u>Table 19</u> shows the LIN pins. For more information see <u>Ref. 1</u> subsection 3.43, LIN master controller.

Table 19. LIN controller pins

Symbol	Direction	Description
LIN0/1 TXDL	out	LIN channel 0/1 transmit data output
LIN0/1 RXDL	in	LIN channel 0/1 receive data input

8.7 Modulation and sampling control subsystem

8.7.1 Overview

The Modulation and Sampling Control Subsystem (MSCSS) in the LPC2917/19 includes four Pulse-Width Modulators (PWMs), three10-bit successive approximation Analog-to-Digital Converters (ADCs) and two timers.

The key features of the MSCSS are:

- Two 10-bit, 400 ksamples/s, 8-channel ADCs with 3.3 V inputs and various triggerstart options
- Four 6-channel PWMs (Pulse-Width Modulators) with capture and trap functionality
- Two dedicated timers to schedule and synchronize the PWMs and ADCs

8.7.2 Description

The MSCSS contains Pulse-Width Modulators (PWMs), Analog-to-Digital Converters (ADCs) and timers.

Figure 7 provides an overview of the MSCSS. An AHB-to-VPB bus bridge takes care of communication with the AHB system bus. Two internal timers are dedicated to this subsystem. MSCSS timer 0 can be used to generate start pulses for the ADCs and the first PWM. The second timer (MSCSS timer 1) is used to generate 'carrier' signals for the PWMs. These carrier patterns can be used, for example, in applications requiring current

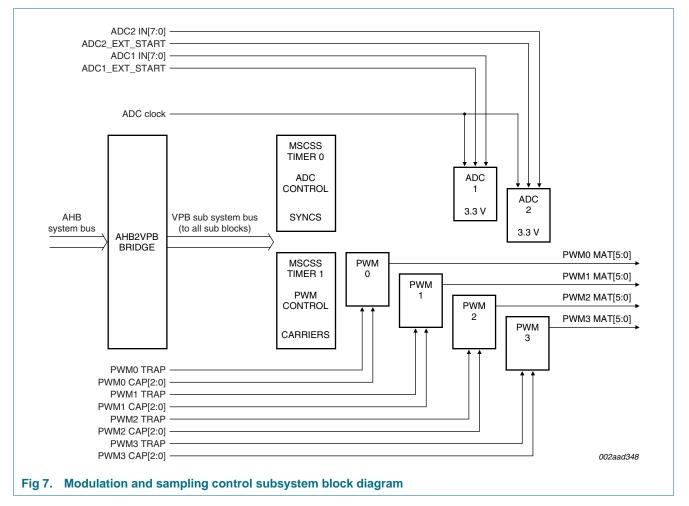
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control. Several other trigger possibilities are provided for the ADCs (external, cascaded or following a PWM). The capture inputs of both timers can also be used to capture the start pulse of the ADCs.

The PWMs can be used to generate waveforms in which the frequency, duty cycle and rising and falling edges can be controlled very precisely. Capture inputs are provided to measure event phases compared to the main counter. Depending on the applications, these inputs can be connected to digital sensor motor outputs or digital external signals. Interrupt signals are generated on several events to closely interact with the CPU.

The ADCs can be used for any application needing accurate digitized data from analog sources. To support applications like motor control, a mechanism to synchronize several PWMs and ADCs is available (sync_in and sync_out).

Note that the PWMs run on the PWM clock and the ADCs on the ADC clock, see <u>Section 8.8.4</u>.



8.7.2.1 Synchronization and trigger features of the MSCSS

The MSCSS contains two internal timers to generate synchronization and carrier pulses for the ADCs and PWMs. Figure 8 shows how the timers are connected to the ADC and PWM modules.

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Each ADC module has four start inputs. An ADC conversion is started when one of the start ADC conditions is valid:

- start 0: ADC external start input pin; can be triggered at a positive or negative edge.
 Note that this signal is captured in the ADC clock domain
- start 1: If the 'preceding' ADC conversion is ended, the sync_out signal starts an ADC conversion. This signal is captured in the MSCSS subsystem clock domain, see <u>Section 8.7.5.2</u>. As can be seen in <u>Figure 8</u>, the sync_out of ADC1 is connected to the start 1 input of ADC2 and the sync_out of ADC2 is connected to the start 1 input of ADC1.
- start 2: The PWM sync_out can start an ADC conversion. The sync_out signal is synchronized to the ADC clock in the ADC module. This signal is captured in the MSCSS subsystem clock domain.
- start 3: The match outputs from MSCSS timer 0 are connected to the start 3 inputs of the ADCs. This signal is captured in the ADC clock domain.

The PWM_sync and trans_enable_in of PWM 0 are connected to the 4th match output of MSCSS timer 0 to start the PWM after a pre-programmed delay. This sync signal is cascaded through all PWMs, allowing a programmable delay offset between subsequent PWMs. The sync delay of each PWM can be programmed synchronously or with a different phase for spreading the power load.

The match outputs of MSCSS timer 1 (PWM control) are connected to the corresponding carrier inputs of the PWM modules. The carrier signal is modulated with the PWM-generated waveforms.

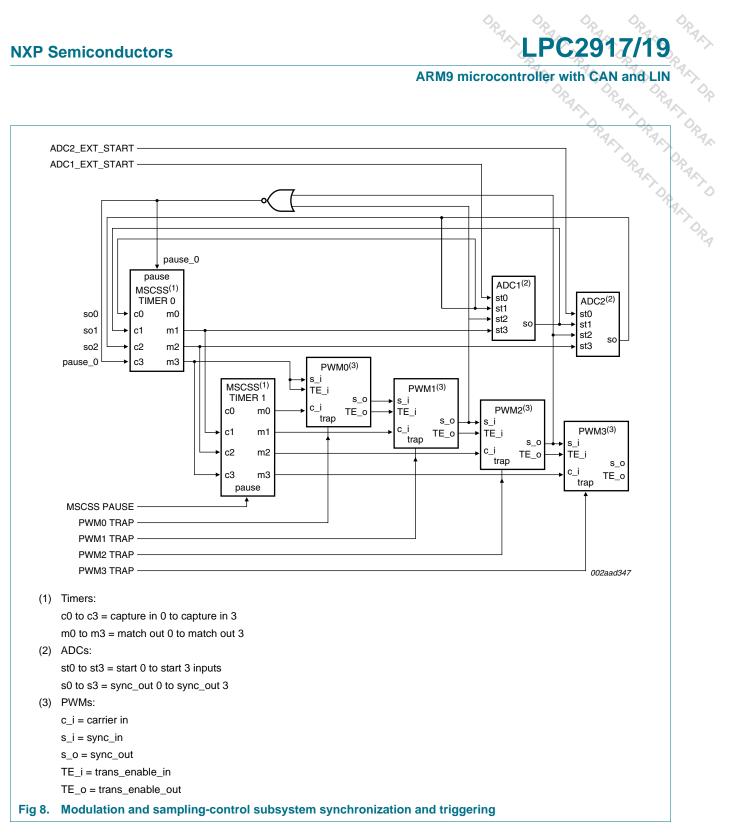
The pause input of MSCSS timer 1 (PWM Control) is connected to an external input pin. Generation of the carrier signal is stopped by asserting the pause of this timer.

The pause input of MSCSS timer 0 (ADC Control) is connected to a 'NOR' of the PWM_sync outputs (start 2 input on the ADCs). If the pause feature of this timer is enabled the timer only counts when one of the PWM_sync outputs is active HIGH. This feature can be used to start the ADC once every x PWM cycles, where x corresponds to the value in the match register of the timer. In this case the start 3 input of the ADC should be enabled (start on match output of MSCSS timer 0).

The signals connected to the capture inputs of the timers (both MSCSS timer 0 and MSCSS timer 1) are intended for debugging.



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8.7.3 MSCSS pin description

The pins of the LPC2917/19 MSCSS associated with the two ADC modules are described in Section 8.7.5.3. Pins directly connected to the four PWM modules are described in Section 8.7.6.5: pins directly connected to the MSCSS timer 1 module are described in Section 8.7.7.3.

8.7.4 MSCSS clock description

The MSCSS is clocked from a number of different sources:

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- CLK_SYS_MSCSS_A clocks the AHB side of the AHB-to-VPB bus bridge
- CLK_MSCSS_VPB clocks the subsystem VPB bus
- CLK MSCSS MTMR0/1 clocks the timers
- CLK MSCSS PWM0..3 clocks the PWMs.

DRAFT U. Each ADC has two clock areas; a VPB part clocked by CLK_MSCSS_ADCx_VPB (x = 1 or 2) and a control part for the analog section clocked by CLK_ADCx = 1 or 2), see Section 7.2.2.

All clocks are derived from the BASE_MSCSS_CLK, except for CLK_SYS_MSCSS_A which is derived form BASE SYS CLK, and the CLK ADCx clocks which are derived from BASE CLK ADC. If specific PWM or ADC modules are not used their corresponding clocks can be switched off.

8.7.5 Analog-to-digital converter

8.7.5.1 Overview

The MSCSS in the LPC2917/19 includes two 10-bit successive-approximation analog-to-digital converters.

The key features of the ADC interface module are:

- ADC1 and ADC2: Eight analog inputs; time-multiplexed; measurement range up to 3.3 V
- External reference-level inputs
- 400 ksamples per second at 10-bit resolution up to 1500 ksamples per second at 2-bit resolution
- Programmable resolution from 2-bit to 10-bit
- Single analog-to-digital conversion scan mode and continuous analog-to-digital conversion scan mode
- Optional conversion on transition on external start input, timer capture/match signal, PWM sync or 'previous' ADC
- · Converted digital values are stored in a register for each channel
- Optional compare condition to generate a 'less than' or an 'equal to or greater than' compare-value indication for each channel
- Power-down mode

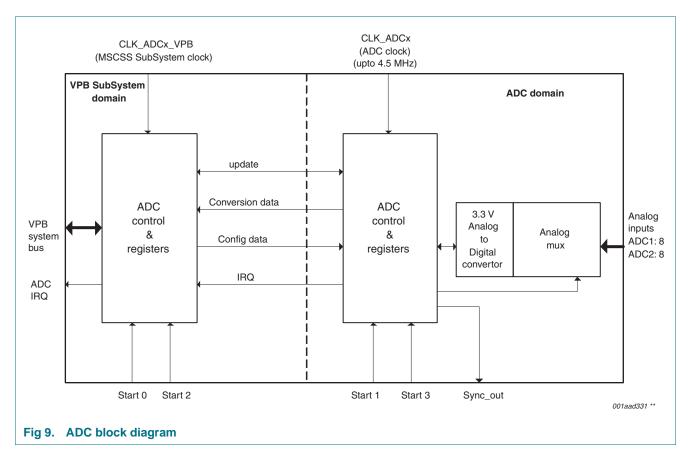
8.7.5.2 Description

The ADC block diagram, Figure 9, shows the basic architecture of each ADC. The ADC functionality is divided into two major parts; one part running on the MSCSS Subsystem clock, the other on the ADC clock. This split into two clock domains affects the behavior from a system-level perspective. The actual analog-to-digital conversions take place in the ADC clock domain, but system control takes place in the system clock domain.

A mechanism is provided to modify configuration of the ADC and control the moment at which the updated configuration is transferred to the ADC domain.

The ADC clock is limited to 4.5 MHz maximum frequency and should always be lower than or equal to the system clock frequency. To meet this constraint or to select the desired lower sampling frequency the clock generation unit provides a programmable fractional system-clock divider dedicated to the ADC clock. Conversion rate is determined by the ADC clock frequency divided by the number of resolution bits plus one. Accessing ADC registers requires an enabled ADC clock, which is controllable via the clock generation unit, see Section 8.8.4.

Each ADC has four start inputs. Note that start 0 and start 2 are captured in the system clock domain while start 1 and start 3 are captured in the ADC domain. The start inputs are connected at MSCSS level, see <u>Section 8.7.2.1</u> for details.



8.7.5.3 ADC pin description

The two ADC modules in the MSCSS have the pins described below. The ADCx input pins are combined with other functions on the port pins of the LPC2917/19. The VREFN and VREFP pins are common for both ADCs. <u>Table 20</u> shows the ADC pins.

Table 20. Analog to digital converter pins

Symbol	Direction	Description
ADCn IN[7:0]	in	analog input for ADCn, channel 7 to channel 0 (n is 1 or 2)
ADCn_EXT_START	in	ADC external start-trigger input (n is 1 or 2)
VREFN	in	ADC LOW reference level
VREFP	in	ADC HIGH reference level

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8.7.5.4 ADC clock description

The ADC modules are clocked from two different sources; $CLK_MSCSS_ADCx_VPB$ and CLK_ADCx (x = 1 or 2), see <u>Section 7.2.2</u>. Note that each ADC has its own CLK_ADCx and $CLK_MSCSS_ADCx_VPB$ branch clocks for power management. If an ADC is unused both its $CLK_MSCSS_ADCx_VPB$ and CLK_ADCx can be switched off.

The frequency of all the CLK_MSCSS_ADCx_VPB clocks is identical to CLK_MSCSS_VPB since they are derived from the same base clock BASE_MSCSS_CLK. Likewise the frequency of all the CLK_ADCx clocks is identical since they are derived from the same base clock BASE_ADC_CLK.

The register interface towards the system bus is clocked by CLK_MSCSS_ADCx_VPB. Control logic for the analog section of the ADC is clocked by CLK_ADCx, see also Figure 9.

8.7.6 PWM

8.7.6.1 Overview

The MSCSS in the LPC2917/19 includes four PWM modules with the following features.

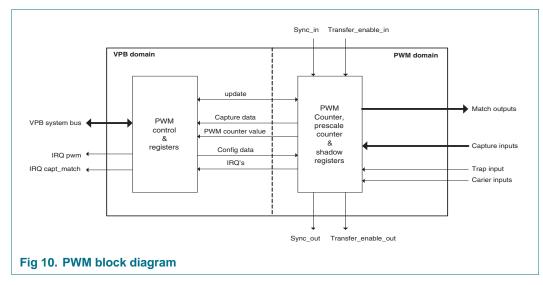
- Six pulse-width modulated output signals
- Double edge features (rising and falling edges programmed individually)
- Optional interrupt generation on match (each edge)
- Different operation modes: continuous or run-once
- 16-bit PWM counter and 16-bit prescale counter allow a large range of PWM periods
- A protective mode (TRAP) holding the output in a software-controllable state and with optional interrupt generation on a trap event
- Three capture registers and capture trigger pins with optional interrupt generation on a capture event
- Interrupt generation on match event, capture event, PWM counter overflow or trap event
- A burst mode mixing the external carrier signal with internally generated PWM
- Programmable sync-delay output to trigger other PWM modules (master/slave behavior)

8.7.6.2 Description

The ability to provide flexible waveforms allows PWM blocks to be used in multiple applications; e.g. automotive dimmer/lamp control and fan control. Pulse-width modulation is the preferred method for regulating power since no additional heat is generated and it is energy-efficient when compared with linear-regulating voltage control networks.

The PWM delivers the waveforms/pulses of the desired duty cycles and cycle periods. A very basic application of these pulses can be in controlling the amount of power transferred to a load. Since the duty cycle of the pulses can be controlled, the desired amount of power can be transferred for a controlled duration. Two examples of such applications are:

- Automotive dimmer controller: The flexibility of providing waves of a desired duty cycle and cycle period allows the PWM to control the amount of power to be transferred to the load. The PWM functions as a dimmer controller in this application
- Motor controller: The PWM provides multi-phase outputs, and these outputs can be controlled to have a certain pattern sequence. In this way the force/torque of the motor can be adjusted as desired. This makes the PWM function as a motor drive.



The PWM block diagram in Figure 10 shows the basic architecture of each PWM. PWM functionality is split into two major parts, a VPB domain and a PWM domain, both of which run on clocks derived from the BASE_MSCSS_CLK. This split into two domains affects behavior from a system-level perspective. The actual PWM and prescale counters are located in the PWM domain but system control takes place in the VPB domain.

The actual PWM consists of two counters; a 16-bit prescale counter and a 16-bit PWM counter. The position of the rising and falling edges of the PWM outputs can be programmed individually. The prescale counter allows high system bus frequencies to be scaled down to lower PWM periods. Registers are available to capture the PWM counter values on external events.

Note that in the Modulation and Sampling SubSystem, each PWM has its individual clock source CLK_MSCSS_PWMx (x runs from 0 to 3). Both the prescale and the timer counters within each PWM run on this clock CLK_MSCSS_PWMx, and all time references are related to the period of this clock. See <u>Section 8.8</u> for information on generation of these clocks.

8.7.6.3 Synchronizing the PWM counters

A mechanism is included to synchronize the PWM period to other PWMs by providing a sync input and a sync output with programmable delay. Several PWMs can be synchronized using the trans_enable_in/trans_enable_out and sync_in/sync_out ports. See <u>Section 8.7.2.1</u> for details of the connections of the PWM modules within the MSCSS in the LPC2917/19. PWM 0 can be master over PWM 1; PWM 1 can be master over PWM 2, etc.

8.7.6.4 Master and slave mode

A PWM module can provide synchronization signals to other modules (also called Master mode). The signal sync_out is a pulse of one clock cycle generated when the internal PWM counter (re)starts. The signal trans_enable_out is a pulse synchronous to sync_out, generated if a transfer from system registers to PWM shadow registers occurred when the PWM counter restarted. A delay may be inserted between the counter start and generation of trans_enable_out and sync_out.

A PWM module can use input signals trans_enable_in and sync_in to synchronize its internal PWM counter and the transfer of shadow registers (Slave mode).

8.7.6.5 **PWM** pin description

Each of the four PWM modules in the MSCSS has the following pins. These are combined with other functions on the port pins of the LPC2917/19. <u>Table 21</u> shows the PWM0 to PWM3 pins.

	i pilio	
Symbol	Direction	Description
PWMn CAP[0]	in	PWM n capture input 0
PWMn CAP[1]	in	PWM n capture input 1
PWMn CAP[2]	in	PWM n capture input 2
PWMn MAT[0]	out	PWM n match output 0
PWMn MAT[1]	out	PWM n match output 1
PWMn MAT[2]	out	PWM n match output 2
PWMn MAT[3]	out	PWM n match output 3
PWMn MAT[4]	out	PWM n match output 4
PWMn MAT[5]	out	PWM n match output 5
PWMn TRAP	in	PWM n trap input

Table 21.PWM pins

8.7.6.6 PWM clock description

The PWM modules are clocked by CLK_MSCSS_PWMx (x = 0-3), see Section 7.2.2. Note that each PWM has its own CLK_MSCSS_PWMx branch clock for power management. The frequency of all these clocks is identical to CLK_MSCSS_VPB since they are derived from the same base clock BASE_MSCSS_CLK.

Also note that unlike the timer modules in the Peripheral SubSystem, the actual timer counter registers of the PWM modules run at the same clock as the VPB system interface CLK_MSCSS_VPB. This clock is independent of the AHB system clock.

If a PWM module is not used its CLK_MSCSS_PWMx branch clock can be switched off.

8.7.7 Timers in the MSCSS

8.7.7.1 Overview

The two timers in the MSCSS are functionally identical to the timers in the peripheral subsystem, see <u>Section 8.4.3</u>. The features of the timers in the MSCSS are the same as the timers in the peripheral subsystem, but the capture inputs and match outputs are not available on the device pins. These signals are instead connected to the ADC and PWM modules as outlined in the description of the MSCSS, see <u>Section 8.7.2</u>.

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8.7.7.2 Description

See section Section 8.4.3.2 for a description of the timers.

8.7.7.3 MSCSS timer-pin description

MSCSS timer 0 has no external pins.

2291 . with CAN and L. MSCSS timer 1 has a PAUSE pin available as external pin. The PAUSE pin is combined with other functions on the port pins of the LPC2917/19. Table 22 shows the MSCSS timer 1 external pin.

Table 22. MSCSS timer 1 pin

Symbol	Direction	Description
MSCSS PAUSE	in	pause pin for MSCSS timer 1

8.7.7.4 MSCSS timer-clock description

The Timer modules in the MSCSS are clocked by CLK_MSCSS_MTMRx (x = 0-1), see Section 7.2.2. Note that each timer has its own CLK MSCSS MTMRx branch clock for power management. The frequency of all these clocks is identical to CLK_MSCSS_VPB since they are derived from the same base clock BASE MSCSS CLK.

Note that, unlike the timer modules in the Peripheral SubSystem, the actual timer counter registers run at the same clock as the VPB system interface CLK_MSCSS_VPB. This clock is independent of the AHB system clock.

If a timer module is not used its CLK MSCSS MTMRx branch clock can be switched off.

8.8 Power, clock and reset control subsystem

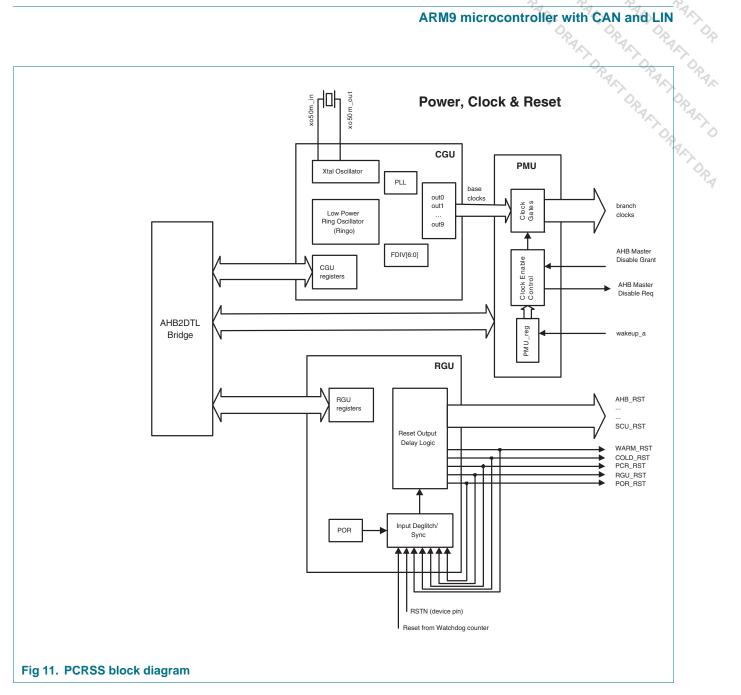
8.8.1 Overview

The Power, Clock and Reset Control Subsystem (PCRSS) in the LPC2917/19 includes a Clock Generator Unit (CGU), a Reset Generator Unit (RGU) and a Power Management Unit (PMU).

8.8.2 Description

Figure 11 provides an overview of the PCRSS. An AHB-to-DTL bridge takes care of communication with the AHB system bus.

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8.8.3 PCR subsystem clock description

The PCRSS is clocked by a number of different clocks. CLK_SYS_PCRSS clocks the AHB side of the AHB to DTL bus bridge and CLK PCR SLOW clocks the CGU, RGU and PMU internal logic, see Section 7.2.2. CLK SYS PCRSS is derived from BASE_SYS_CLK, which can be switched off in low-power modes. CLK_PCR_SLOW is derived from BASE PCR CLK and is always on in order to be able to wake up from low-power modes.

8.8.4 Clock Generation Unit (CGU)

8.8.4.1 Overview

The key features are:

- Generation of 10 and 2 test-base clocks, selectable from several embedded clock • DRAFT D T DRAFT D RAFT DR sources
- Crystal oscillator with power-down
- Control PLL with power-down
- Very low-power ring oscillator, always on to provide a 'safe clock'
- Seven fractional clock dividers with L/D division
- Individual source selector for each base clock, with glitch-free switching
- · Autonomous clock-activity detection on every clock source
- · Protection against switching to invalid or inactive clock sources
- Embedded frequency counter •
- Register write-protection mechanism to prevent unintentional alteration of clocks •

Remark: Any clock-frequency adjustment has a direct impact on the timing of on-board peripherals such as the UARTs, SPI, watchdog, timers, CAN controller, LIN master controller, ADCs or flash-memory interface.

8.8.4.2 Description

The clock generation unit provides 10 internal clock sources as described in Table 23.

NumberNameFrequency (MHz) [1]Description0BASE_SAFE_CLK0.4Base safe clock (always on)1BASE_SYS_CLK80Base system clock2BASE_PCR_CLK0.4 [2]Base PCR subsystem clock3BASE_IVNSS_CLK80Base IVNSS subsystem clock4BASE_MSCSS_CLK80Base MSCSS subsystem clock5BASE_UART_CLK80Base UART clock6BASE_SPI_CLK40Base SPI clock7BASE_TMR_CLK80Base timers clock8BASE_ADC_CLK4.5Base ADCs clock	Table 23.	CGU base clocks		
1BASE_SYS_CLK80Base system clock2BASE_PCR_CLK0.4 [2]Base PCR subsystem clock3BASE_IVNSS_CLK80Base IVNSS subsystem clock4BASE_MSCSS_CLK80Base MSCSS subsystem clock5BASE_UART_CLK80Base UART clock6BASE_SPI_CLK40Base SPI clock7BASE_TMR_CLK80Base timers clock	Number	Name		Description
2BASE_PCR_CLK0.4 [2]Base PCR subsystem clock3BASE_IVNSS_CLK80Base IVNSS subsystem clock4BASE_MSCSS_CLK80Base MSCSS subsystem clock5BASE_UART_CLK80Base UART clock6BASE_SPI_CLK40Base SPI clock7BASE_TMR_CLK80Base timers clock	0	BASE_SAFE_CLK	0.4	Base safe clock (always on)
3BASE_IVNSS_CLK80Base IVNSS subsystem clock4BASE_MSCSS_CLK80Base MSCSS subsystem clock5BASE_UART_CLK80Base UART clock6BASE_SPI_CLK40Base SPI clock7BASE_TMR_CLK80Base timers clock	1	BASE_SYS_CLK	80	Base system clock
4BASE_MSCSS_CLK80Base MSCSS subsystem clock5BASE_UART_CLK80Base UART clock6BASE_SPI_CLK40Base SPI clock7BASE_TMR_CLK80Base timers clock	2	BASE_PCR_CLK	0.4 [2]	Base PCR subsystem clock
5BASE_UART_CLK80Base UART clock6BASE_SPI_CLK40Base SPI clock7BASE_TMR_CLK80Base timers clock	3	BASE_IVNSS_CLK	80	Base IVNSS subsystem clock
6BASE_SPI_CLK40Base SPI clock7BASE_TMR_CLK80Base timers clock	4	BASE_MSCSS_CLK	80	Base MSCSS subsystem clock
7 BASE_TMR_CLK 80 Base timers clock	5	BASE_UART_CLK	80	Base UART clock
	6	BASE_SPI_CLK	40	Base SPI clock
8 BASE_ADC_CLK 4.5 Base ADCs clock	7	BASE_TMR_CLK	80	Base timers clock
	8	BASE_ADC_CLK	4.5	Base ADCs clock

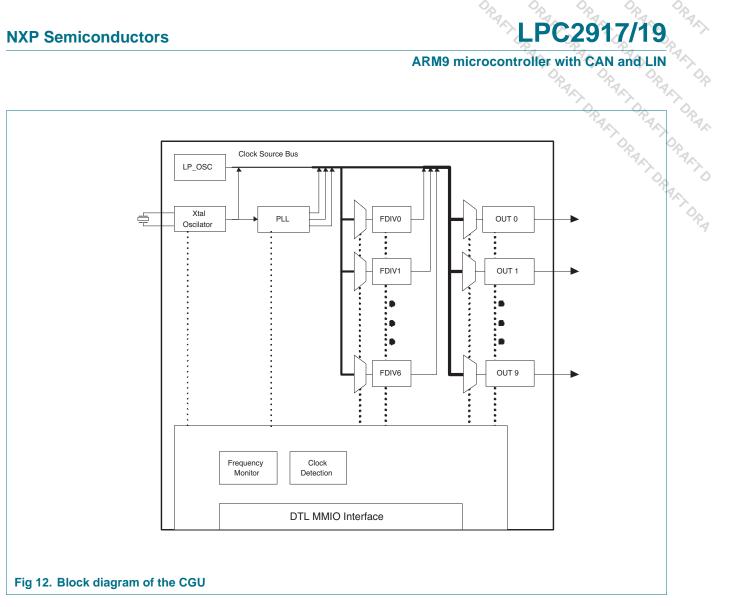
Table 23 CGU base clocks

[1] Maximum frequency that guarantees stable operation of the LPC2917/19.

[2] Fixed to low-power oscillator.

For generation of these base clocks, the CGU consists of primary and secondary clock generators and one output generator for each base clock.



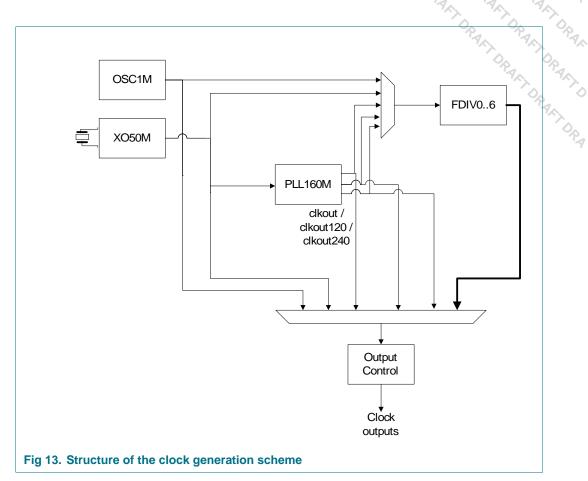


There are two primary clock generators: a low-power ring oscillator (LP_OSC) and a crystal oscillator. See Figure 12.

LP OSC is the source for the BASE PCR CLK that clocks the CGU itself and for BASE_SAFE_CLK that clocks a minimum of other logic in the device (like the watchdog timer). To prevent the device from losing its clock source LP_OSC cannot be put into power-down. The crystal oscillator can be used as source for high-frequency clocks or as an external clock input if a crystal is not connected.

Secondary clock generators are a PLL and seven fractional dividers (FDIV0..6). The PLL has three clock outputs: normal, 120° phase-shifted and 240° phase-shifted.

Configuration of the CGU: For every output generator - generating the base clocks - a choice can be made from the primary and secondary clock generators according to Figure 13.



Any output generator (except for BASE_SAFE_CLK and BASE_PCR_CLK) can be connected to either a fractional divider (FDIV0..6) or to one of the outputs of the PLL or to LP_OSC/crystal oscillator directly. BASE_SAFE_CLK and BASE_PCR_CLK can use only LP_OSC as source.

The fractional dividers can be connected to one of the outputs of the PLL or directly to LP_OSC/crystal Oscillator.

The PLL can be connected to the crystal oscillator.

In this way every output generating the base clocks can be configured to get the required clock. Multiple output generators can be connected to the same primary or secondary clock source, and multiple secondary clock sources can be connected to the same PLL output or primary clock source.

Invalid selections/programming - connecting the PLL to an FDIV or to one of the PLL outputs itself for example - will be blocked by hardware. The control register will not be written, the previous value will be kept, although all other fields will be written with new data. This prevents clocks being blocked by incorrect programming.

Default Clock Sources: Every secondary clock generator or output generator is connected to LP_OSC at reset. In this way the device runs at a low frequency after reset. It is recommended to switch BASE_SYS_CLK to a high-frequency clock generator as (one of) the first step(s) in the boot code after verifying that the high-frequency clock generator is running.

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Clock Activity Detection: Clocks that are inactive are automatically regarded as invalid, and values of 'CLK_SEL' that would select those clocks are masked and not written to the control registers. This is accomplished by adding a clock detector to every clock generator. The RDET register keeps track of which clocks are active and inactive, and the appropriate 'CLK_SEL' values are masked and unmasked accordingly. Each clock detector can also generate interrupts at clock activation and deactivation so that the system can be notified of a change in internal clock status.

Clock detection is done using a counter running at the BASE_PCR_CLK frequency. If no positive clock edge occurs before the counter has 32 cycles of BASE_PCR_CLK the clock is assumed to be inactive. As BASE_PCR_CLK is slower than any of the clocks to be detected, normally only one BASE_PCR_CLK cycle is needed to detect activity. After reset all clocks are assumed to be 'non-present', so the RDET status register will be correct only after 32 BASE_PCR_CLK cycles.

Note that this mechanism cannot protect against a currently-selected clock going from active to inactive state. Therefore an inactive clock may still be sent to the system under special circumstances, although an interrupt can still be generated to notify the system.

Glitch-Free Switching: Provisions are included in the CGU to allow clocks to be switched glitch-free, both at the output generator stage and also at secondary source generators.

In the case of the PLL the clock will be stopped and held low for long enough to allow the PLL to stabilize and lock before being re-enabled. For all non-PLL Generators the switch will occur as quickly as possible, although there will always be a period when the clock is held low due to synchronization requirements.

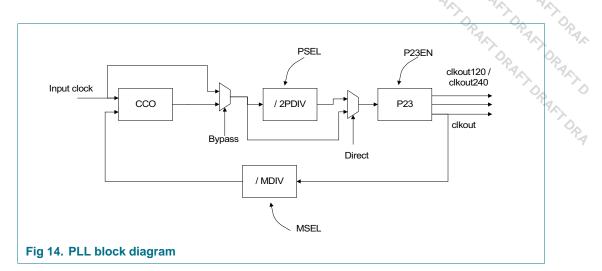
If the current clock is high and does not go low within 32 cycles of BASE_PCR_CLK it is assumed to be inactive and is asynchronously forced low. This prevents deadlocks on the interface.

8.8.4.3 PLL functional description

A block diagram of the PLL is shown in Figure 14. The input clock is fed directly to the analog section. This block compares the phase and frequency of the inputs and generates the main clock². These clocks are either divided by 2*P by the programmable post divider to create the output clock, or sent directly to the output. The main output clock is then divided by M by the programmable feedback divider to generate the feedback clock. The output signal of the analog section is also monitored by the lock detector to signal when the PLL has locked onto the input clock.

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^{2.} Generation of the main clock is restricted by the frequency range of the PLL clock input. See <u>Table 31</u>, Dynamic characteristics.



Triple output phases

For applications that require multiple clock phases two additional clock outputs can be enabled by setting register P23EN to '1', thus giving three clocks with a 120° phase difference. In this mode all three clocks generated by the analog section are sent to the output dividers. When the PLL has not yet achieved lock the second and third phase output dividers run unsynchronized, which means that the phase relation of the output clocks is unknown. When the PLL LOCK register is set the second and third phase of the output dividers are synchronized to the main output clock CLKOUT PLL, thus giving three clocks with a 120° phase difference.

Direct output mode

In normal operating mode (with DIRECT set to '0') the CCO clock is divided by 2, 4, 8 or 16 depending on the value on the PSEL[1:0] input, giving an output clock with a 50% duty cycle. If a higher output frequency is needed the CCO clock can be sent directly to the output by setting DIRECT to '1'. Since the CCO does not directly generate a 50% duty cycle clock, the output clock duty cycle in this mode can deviate from 50%.

Power-down control

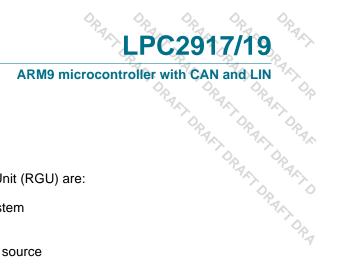
A power-down mode has been incorporated to reduce power consumption when the PLL clock is not needed. This is enabled by setting the PD control register bit. In this mode the analog section of the PLL is turned off, the oscillator and the phase-frequency detector are stopped and the dividers enter a reset state. While in power-down mode the LOCK output is low, indicating that the PLL is not in lock. When power-down mode is terminated by clearing the PD control-register bit the PLL resumes normal operation, and makes the LOCK signal high once it has regained lock on the input clock.

8.8.4.4 CGU pin description

The CGU module in the LPC2917/19 has the pins listed in Table 24 below.

Table 24. CGU	pins	
Symbol	Direction	Description
XOUT_OSC	out	Oscillator crystal output
XIN_OSC	in	Oscillator crystal input or external clock input

Table 24. CGU pins



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8.8.5 Reset Generation Unit (RGU)

8.8.5.1 Overview

The key features of the Reset Generation Unit (RGU) are:

- · Reset controlled individually per subsystem
- Automatic reset stretching and release
- Monitor function to trace resets back to source
- · Register write-protection mechanism to prevent unintentional resets

8.8.5.2 Description

The RGU controls all internal resets.

Each reset output is defined as a (combination of) reset input sources including the external reset input pins and internal power-on reset, see Table 25. The first five resets listed in this table form a sort of cascade to provide the multiple levels of impact that a reset may have. The combined input sources are logically OR-ed together so that activating any of the listed reset sources causes the output to go active.

Reset Output	Reset Source	parts of the device reset when activated
POR_RST	power-on reset module	LP_OSC; is source for RGU_RST
RGU_RST	POR_RST, RSTN pin	RGU internal; is source for PCR_RST
PCR_RST	RGU_RST, WATCHDOG	PCR internal; is source for COLD_RST
COLD_RST	PCR_RST	parts with COLD_RST as reset source below
WARM_RST	COLD_RST	parts with WARM_RST as reset source below
SCU_RST	COLD_RST	SCU
CFID_RST	COLD_RST	CFID
FMC_RST	COLD_RST	embedded Flash-Memory Controller (FMC)
EMC_RST	COLD_RST	embedded SRAM-Memory Controller
SMC_RST	COLD_RST	external Static-Memory Controller (SMC)
GESS_A2V_RST	WARM_RST	GeSS AHB-to-VPB bridge
PESS_A2V_RST	WARM_RST	PeSS AHB-to-VPB bridge
GPIO_RST	WARM_RST	all GPIO modules
UART_RST	WARM_RST	all UART modules
TMR_RST	WARM_RST	all Timer modules in PeSS
SPI_RST	WARM_RST	all SPI modules
IVNSS_A2V_RST	WARM_RST	IVNSS AHB-to-VPB bridge
IVNSS_CAN_RST	WARM_RST	all CAN modules including Acceptance filter
IVNSS_LIN_RST	WARM_RST	all LIN modules
MSCSS_A2V_RST	WARM_RST	MSCSS AHB to VPB bridge
MSCSS_PWM_RST	WARM_RST	all PWM modules
MSCSS_ADC_RST	WARM_RST	all ADC modules
MSCSS_TMR_RST	WARM_RST	all Timer modules in MSCSS
VIC_RST	WARM_RST	Vectored Interrupt Controller (VIC)
AHB_RST	WARM_RST	CPU and AHB Multilayer Bus infrastructure

Table 25. Reset output configuration

8.8.5.3 RGU pin description

12 DRA The RGU module in the LPC2917/19 has the following pins. Table 26 shows the RGU pins.

RGU pin descri	ption	
The RGU modul pins.	e in the LF	PC2917/19 has the following pins. <u>Table 26</u> shows the RGU
Table 26. RGU	oins	Op O
Symbol	Directio n	Description
RSTN	IN	external reset input, Active LOW; pulled up internally

8.8.6 Power Management Unit (PMU)

8.8.6.1 Overview

This module enables software to actively control the system's power consumption by disabling clocks not required in a particular operating mode.

Using the base clocks from the CGU as input, the PMU generates branch clocks to the rest of the LPC2917/19. Output clocks branched from the same base clock are phaseand frequency-related. These branch clocks can be individually controlled by software programming.

The key features are:

- Individual clock control for all LPC2917/19 sub-modules
- Activates sleeping clocks when a wake-up event is detected
- Clocks can be individually disabled by software
- · Supports AHB master-disable protocol when AUTO mode is set
- · Disables wake-up of enabled clocks when power-down mode is set
- Activates wake-up of enabled clocks when a wake-up event is received
- Status register is available to indicate if an input base clock can be safely switched off (i.e. all branch clocks are disabled)

8.8.6.2 Description

The PMU controls all internal clocks of the device for power-mode management. With some exceptions, each branch clock can be switched on or off individually under control of software register bits located in its individual configuration register. Some branch clocks controlling vital parts of the device operate in a fixed mode. Table 27 shows which modecontrol bits are supported by each branch clock.

By programming the configuration register the user can control which clocks are switched on or off, and which clocks are switched off when entering power-down mode.

Note that the standby-wait-for-interrupt instructions of the ARM968E-S processor (putting the ARM CPU into a low-power state) are not supported. Instead putting the ARM CPU into power-down should be controlled by disabling the branch clock for the CPU.

Remark: For any disabled branch clocks to be re-activated their corresponding base clocks must be running (controlled by the CGU).

Table 27 shows the relation between branch and base clocks, see also Section 7.2.1. Every branch clock is related to one particular base clock: it is not possible to switch the source of a branch clock in the PMU.

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Table 27. Branch clock overview

Legend:

tors		DRAN	LPC29	017/19
	ARM	19 microcon	troller with C	AN and LIN
			RAND	PAR
Table 27. Branch clock o	verview		0	PAC PA
"0" Indicates that the related	l register bit is tied off to logic l register bit is tied off to logic l register bit is readable and	c LOW, all write	tes are ignored es are ignored	AN and LIN
Branch Clock Name	Base Clock	Implemente Mechanism	d Switch On/O	ff
		WAKEUP	AUTO	RUN
CLK_SAFE	BASE_SAFE_CLK	0	0	1
CLK_SYS_CPU	BASE_SYS_CLK	+	+	1
CLK_SYS	BASE_SYS_CLK	+	+	1
 CLK_SYS_PCR	BASE_SYS_CLK	+	+	1
CLK_SYS_FMC	BASE_SYS_CLK	+	+	+
CLK_SYS_RAM0	BASE_SYS_CLK	+	+	+
CLK_SYS_RAM1	BASE_SYS_CLK	+	+	+
CLK_SYS_SMC	BASE_SYS_CLK	+	+	+
CLK_SYS_GESS	BASE_SYS_CLK	+	+	+
CLK_SYS_VIC	BASE_SYS_CLK	+	+	+
CLK_SYS_PESS	BASE_SYS_CLK	+	+	+
CLK_SYS_GPIO0	BASE_SYS_CLK	+	+	+
CLK_SYS_GPI00	BASE_SYS_CLK	+		
CLK_SYS_GPIO2	BASE_SYS_CLK		+	+
		+	+	+
CLK_SYS_GPIO3	BASE_SYS_CLK	+	+	+
CLK_SYS_IVNSS_A	BASE_SYS_CLK	+	+	+
CLK_SYS_MSCSS_A	BASE_SYS_CLK	+	+	+
CLK_SYS_CHCA	BASE_SYS_CLK	+	+	+
CLK_SYS_CHCB	BASE_SYS_CLK	+	+	+
CLK_PCR_SLOW	BASE_PCR_CLK	+	+	1
CLK_IVNSS_VPB	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_CANC0	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_CANC1	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_LIN0	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_LIN1	BASE_IVNSS_CLK	+	+	+
CLK_MSCSS_VPB	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_MTMR0	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_MTMR1	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM0	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM1	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM2	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM3	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_ADC1_VPB	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_ADC2_VPB	BASE_MSCSS_CLK	+	+	+
CLK_UART0	BASE_UART_CLK	+	+	+
CLK_UART1	BASE_UART_CLK	+	+	+
	·	-	-	-

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Table 27. Branch clock overview ... continued

Legend:

ctors		DRAN		2917/19
	ARM	19 microcon	troller with	CAN and LI
Legend: "1" Indicates that the relate "0" Indicates that the relate	overviewcontinued ed register bit is tied off to logic ed register bit is tied off to logic ed register bit is readable and	c HIGH, all wr c LOW, all wri	ites are ignor	CRACTOR AR
Branch Clock Name	Base Clock	Implemente Mechanism	ed Switch Or	n/Off
		WAKEUP	AUTO	RUN
CLK_SPI0	BASE_SPI_CLK	+	+	+
CLK_SPI1	BASE_SPI_CLK	+	+	+
CLK_SPI2	BASE_SPI_CLK	+	+	+
CLK_TMR0	BASE_TMR_CLK	+	+	+
CLK_TMR1	BASE_TMR_CLK	+	+	+
CLK_TMR2	BASE_TMR_CLK	+	+	+
CLK_TMR3	BASE_TMR_CLK	+	+	+
CLK_ADC1	BASE_ADC_CLK	+	+	+
CLK_ADC2	BASE_ADC_CLK	+	+	+
CLK_TESTSHELL_IP	BASE_CLK_TESTSHELL	0	0	1

8.8.6.3 PMU pin description

The PMU has no external pins.

8.9 Vectored interrupt controller

8.9.1 Overview

The LPC2917/19 contains a very flexible and powerful Vectored Interrupt Controller (VIC) to interrupt the ARM processor on request.

The key features are:

- Level-active interrupt request with programmable polarity
- 56 interrupt-request inputs
- Software-interrupt request capability associated with each request input
- Observability of interrupt-request state before masking
- Software-programmable priority assignments to interrupt requests up to 15 levels
- Software-programmable routing of interrupt requests towards the ARM-processor inputs IRQ and FIQ
- · Fast identification of interrupt requests through vector
- Support for nesting of interrupt service routines

8.9.2 Description

The Vectored Interrupt Controller routes incoming interrupt requests to the ARM processor. The interrupt target is configured for each interrupt request input of the VIC. The targets are defined as follows:

- Target 0 is ARM processor FIQ (fast interrupt service)
- Target 1 is ARM processor IRQ (standard interrupt service)

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Interrupt-request masking is performed individually per interrupt target by comparing the priority level assigned to a specific interrupt request with a target-specific priority threshold. The priority levels are defined as follows:

- Priority level 0 corresponds to 'masked' (i.e. interrupt requests with priority 0 never lead to an interrupt)
- Priority 1 corresponds to the lowest priority
- · Priority 15 corresponds to the highest priority

Software interrupt support is provided and can be supplied for:

- Testing RTOS interrupt handling without using device-specific interrupt service routines
- Software emulation of an interrupt-requesting device, including interrupts

8.9.3 VIC pin description

The VIC module in the LPC2917/19 has no external pins.

8.9.4 VIC clock description

The VIC is clocked by CLK_SYS_VIC, see Section 7.2.2.

9. Limiting values

Table 28.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
Supply pins					
P _{tot}	Total power dissipation.		[1] -	1	W
V _{DD(CORE)}	Core supply voltage.		-0.5	+2.0	V
V _{DD(OSC_PLL)}	Oscillator and PLL supply voltage.		-0.5	+2.0	V
V _{DD(ADC3V3)}	3.3 V ADC supply voltage.		-0.5	+4.6	V
V _{DD(IO)}	I/O digital supply voltage.		-0.5	+4.6	V
I _{DD}	Supply current.	Average value per supply pin.	[2] _	98	mA
I _{SS}	Ground current.	Average value per ground pin.	[2] -	98	mA
Input pins an	d I/O pins				
V _{XIN_OSC}	Voltage on pin XIN_OSC.		-0.5	+2.0	V
V _{XIN_RTC}	Voltage on pin XIN_RTC.		-0.5	+2.0	V
V _{I(IO)}	I/O input voltage.		<u>[3][4][5]</u> –0.5	$V_{DD(IO)}$ + 3.0	V
V _{I(ADC)}	ADC input voltage.	I/O port 0.	<u>[4][5]</u> –0.5	$V_{DD(ADC3V3)}$ + 0.5	V
V _{VREFP}	Voltage on pin VREFP.		-0.5	+3.6	V
V _{VREFN}	Voltage on pin VREFN.		-0.5	+3.6	V
I _{I(ADC)}	ADC input current.	Average value per input pin.	[2] _	35	mA

Output pins and I/O pins configured as output

Table 28. Limiting values ... continued

NXP Sem	niconductors			OPA	LPC2	917/19
	Limiting values continued the Absolute Maximum Re	ating System (IEC 60134).	LPC2917/1 ARM9 microcontroller with CAN and L Min Max Unit			CAN and LIN
Symbol	Parameter	Conditions		Min	Max	Unit
I _{OHS}	HIGH-state short-circuit output current.	Drive HIGH, output shorted to VSS(IO).	<u>[9]</u>	-	-33	mA mA
I _{OLS}	LOW-state short-circuit output current.	Drive LOW, output shorted to VDD(IO).	<u>[9]</u>	-	+38	mA
General						
T _{stg}	Storage temperature.			-40	+150	°C
T _{amb}	Ambient temperature.			-40	+85	°C
T _{vj}	Virtual junction temperature.			<u>[6]</u> –40	+125	°C
Memory						
n _{endu(fl)}	Endurance of flash memory.			-	100 000	cycle
t _{ret(fl)}	Flash memory retention time.			-	20	year
Electrostati	c discharge					
V _{esd}	Electrostatic discharge	On all pins.				
	voltage.	Human body model.		<u>[7]</u> –2000	+2000	V
		Machine model.		<u>[8]</u> –200	+200	V
		Charged device model.		-500	+500	V
		On corner pins.				
		Charged device model.		-750	+750	V

[1] Based on package heat transfer, not device power consumption.

[2] Peak current must be limited at 25 times average current.

[3] For I/O Port 0, the maximum input voltage is defined by V_{I(ADC)}.

Only when V_{DD(IO)} is present. [4]

Note that pull-up should be off. With pull-up do not exceed 3.6 V. [5]

[6] In accordance with IEC 60747-1. An alternative definition of the virtual junction temperature is: $T_{vj} = T_{amb} + P_{tot} \times R_{th(j-a)}$ where $R_{th(j-a)}$ is a fixed value; see Section 10. The rating for Tvi limits the allowable combinations of power dissipation and ambient temperature.

Human-body model: discharging a 100 pF capacitor via a 10 k Ω series resistor. [7]

Machine model: discharging a 200 pF capacitor via a 0.75 μ H series inductance and 10 Ω resistor. [8]

[9] 112 mA per V_{DD(IO)} or V_{SS(IO)} should not be exceeded.

10. Thermal characteristics

Table 29.	Thermal characteristics				
Symbol	Parameter	Conditions	Value	Unit	
R _{th(j-a)}	thermal resistance from	in free air			
	junction to ambient	package;			
		LQFP144	62	K/W	

11. Static characteristics

Table 30. Static characteristics

				ARM9 m	icrocontro	ller with CAI	N and LIN
11. Statio	c characteristics					RALTORA	PARTORAL
$V_{DD(CORE)} = V$	atic characteristics $DD(OSC_PLL)$; $V_{DD(IO)} = 2.7 V$ a respect to ground; positive		/ to 3.6 unless (V; T _{vj} = -40 otherwise s _i) °C to +125 pecified.[<u>1]</u>	PC291 Iler with CAI	are
Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
Supplies							
Core supply							
V _{DD(CORE)}	Core supply voltage.			1.71	1.80	1.89	V
I _{DDD(CORE)}	Core supply current.	ARM9 and all peripherals active at max clock speeds.		-	1.1	2.5	mA/ MHz
		All clocks off.	[2]	-	30	450	μA
I/O supply							
V _{DD(IO)} Oscillator sup	I/O digital supply voltage.			2.7	-	3.6	V
V _{DD(OSC_PLL)}	Oscillator and PLL supply voltage.			1.71	1.80	1.89	V
IDDD(OSC_PLL)	Oscillator and PLL supply current.	start-up		1.5	-	3	mA
		Normal mode		-	-	1	mA
		Power-down mode		-	-	2	μA
Analog-to-digi	tal converter supply						
V _{DD(A3V3)}	3.3 V ADC supply voltage			3.0	3.3	3.6	V
I _{DDA(A3V3)}	3.3 V ADC analog supply	Normal mode		-	-	1.9	mA
	current.	Power-down mode		-	-	4	μA
	d I/O pins configured as in	•					
VI	Input voltage.	All port pins and $V_{DD(IO)}$ applied except port 0 pins 16 to 31. see Section 9	<u>[7][8]</u>	-0.5	-	+ 5.5	V
		Port 0 pins 16 to 31.	<u>[8]</u>			V _{VREFP}	
		All port pins and $V_{DD(IO)}$ not applied.	-	-0.5	-	+3.6	V
		All other I/O pins, RESET_N, TRST_N, TDI, JTAGSEL, TMS, TCK.		-0.5	-	VDD(IO)	V
V _{IH}	HIGH-state input voltage.	All port pins, RESET_N, TRST_N, TDI, JTAGSEL, TMS, TCK.		2.0	-	-	V
V _{IL}	LOW-state input voltage.	All port pins, RESET_N, TRST_N, TDI, JTAGSEL, TMS, TCK.		-	-	0.8	V
V _{hys}	Hysteresis voltage.			0.4	-	-	V
I _{LIH}	HIGH-state input leakage current.			-	-	1	μΑ



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Table 30. Static characteristics ... continued

Ranare Art DRAK $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DD(A3V3)} = 3.0$ V to 3.6 V; $T_{vj} = -40$ °C to +125 °C; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.^[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{LIL}	LOW-state input leakage current.		-	-	1	μA
I _{I(pd)}	Pull-down input current.	All port pins, $V_I = 3.3 V$; $V_I = 5.5 V$.	25	50	100	μΑ
I _{I(pu)}	Pull-up input current.	All port pins, RESET_N, TRST_N, TDI, JTAGSEL, TMS: $V_I = 0$ V; $V_I > 3.6$ V is not allowed.	-25	-50	-100	μΑ
Ci	Input capacitance.		<u>[3]</u>	3	8	pF
Output pins	and I/O pins configured as ou	Itput				
Vo	Output voltage.		0	-	V _{DD(IO)}	V
V _{OH}	HIGH-state output voltage.	$I_{OH} = -4 \text{ mA}$	$V_{DD(IO)} - 0.4$	-	-	V
V _{OL}	LOW-state output voltage.	$I_{OL} = 4 \text{ mA}$	-	-	0.4	V
CL	Load capacitance.		-	-	25	pF
Analog-to-o	digital converter supply					
V _{VREFN}	Voltage on pin VREFN.		0	-	$V_{VREFP}-2$	V
V _{VREFP}	Voltage on pin VREFP.		V _{VREFN} + 2	-	V _{DD(A3V3)}	V
V _{I(ADC)}	ADC input voltage on port 0 pins	Port 0.	V _{VREFN}	-	V_{VREFP}	V
Z _i	Input impedance.	Between VREFN and VREFP	4.4	-	-	kΩ
		Between VREFN and VDD(A5V)	13.7	-	23.6	kΩ
FSR	Full scale range.		2	-	10	bit
INL	Integral non-linearity.		-1	-	+1	LSB
DNL	Differential non-linearity.		-1	-	+1	LSB
Verr(offset)	Offset error voltage.		-20	-	+20	mV
Verr(FS)	Full-scale error voltage.		-20	-	+20	mV

Table 30. Static characteristics ... continued

LPC291... ARM9 microcontroller with CAN and LIN $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DD(A3V3)} = 3.0$ V to 3.6 V; $T_{vj} = -40$ °C to +125 °C; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Oscillator						Op
R _{s(xtal)}	Crystal series resistance.	$f_{osc} = 10 \text{ MHz}$ to 15 MHz	[5]			
		$C_{xtal} = 10 \text{ pF};$ $C_{ext} = 18 \text{ pF}$	-	-	160	Ω
		$C_{xtal} = 20 \text{ pF};$ $C_{ext} = 39 \text{ pF}$	-	-	60	Ω
		f_{osc} = 15 MHz to 20 MHz	<u>[5]</u>			
		$C_{xtal} = 10 \text{ pF};$ $C_{ext} = 18 \text{ pF}$	-	-	80	Ω
Ci	Input capacitance of XIN_OSC.		<u>[9]</u> _		2	pF
Power-up re	set					
V _{trip(high)}	High trip-level voltage.		<u>6</u> 1.2	1.4	1.6	V
V _{trip(low)}	Low trip-level voltage.		<u>6</u> 1.1	1.3	1.5	V
V _{trip(dif)}	Difference between high and low trip-level voltages.		<u>6</u> 50	120	180	mV

[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at T_{amb} = 125 °C on wafer level. Cased products are tested at Tamb = 25 °C (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power-supply voltage range.

[2] Leakage current is exponential to temperature; worst-case value is at 125 C Tvj. All clocks off. Analog modules and FLASH powered down.

- For Port 0, pin 0 to pin 15 add maximum 1.5 pF for input capacitance to ADC. For Port 0, pin 16 to pin 31 add maximum 1.0 pF for input [3] capacitance to ADC.
- [4] This value is the minimum drive capability. Maximum short-circuit output current is 33 mA (drive HIGH-level, shorted to ground) or -38 mA. (drive LOW-level, shorted to V_{DD(IO)}). The device will be damaged if multiple outputs are shorted.
- [5] C_{xtal} is crystal load capacitance and C_{ext} are the two external load capacitors.
- The power-up reset has a time filter: V_{DD(CORE)} must be above V_{trip(high)} for 2 µs before reset is de-asserted; V_{DD(CORE)} must be below [6] Vtrip(low) for 11 µs before internal reset is asserted.
- [7] Not 5 V-tolerant when pull-up is on.
- For I/O Port 0, the maximum input voltage is defined by V_{I(ADC)}. [8]
- This parameter is not part of production testing or final testing, hence only a typical value is stated. Maximum and minimum values are [9] based on simulation results.

12. Dynamic characteristics

Table 31. **Dynamic characteristics**

 $V_{DD(CORE)} = V_{DD(OSC PLL)}$; $V_{DD(IO)} = 2.7 \text{ V to } 3.6 \text{ V}$; $V_{DD(A3V3)} = 3.0 \text{ V to } 3.6 \text{ V}$; $T_{vi} = -40 \text{ °C}$; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I/O pins						
t _{THL}	HIGH-to-LOW transition time.	C _L = 30 pF	4	-	13.8	ns
t _{TLH}	LOW-to-HIGH transition time.	C _L = 30 pF	4	-	13.8	ns

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Table 31. Dynamic characteristics ...continued

, ,						~>
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Internal clock	, 					0
f _{clk(sys)}	System clock frequency. See <u>Table 23</u> .	ntinued o 3.6 V; V _{DD(A3V3)} = 3.0 V to 3 o the IC; unless otherwise spe Conditions	10	-	80	MHz
T _{clk(sys)}	System clock period. See <u>Table 23</u> .		12.5	-	100	ns
Low-Power R	ing Oscillator					
f _{ref(RO)}	RO reference frequency.		0.36	0.4	0.42	MHz
t _{startup}	Start-up time.	At maximum frequency	-	6	100	μS
Oscillator						
f _{i(osc)}	Oscillator input frequency.	Maximum frequency is the clock input of an external clock source applied to the Xin pin.	10	-	80	MHz
t _{startup}	Start-up time.	At maximum frequency. [2] [3]	-	500	-	μS
PLL						
f _{i(PLL)}	PLL input frequency.		10	-	25	MHz
f _{o(PLL)}	PLL output frequency.		10	-	160	MHz
		CCO; direct mode.	156	-	320	MHz
Analog-to-dig	jital converter					
f _{i(ADC)}	ADC input frequency.	<u>[4]</u>	4	-	4.5	MHz
f _{s(max)}	Maximum sampling rate.	$\begin{array}{l} f_{i(ADC)} = 4.5 \text{ MHz}; \\ f_s = f_{i(ADC)}/(n+1) \text{ with} \\ n = resolution \end{array}$				
		resolution 2 bit	-	-	1500	ksample/s
		resolution 10 bit	-	-	400	ksample/s
t _{conv}	Conversion time.	In number of ADC clock cycles.	3	-	11	cycles
		In number of bits.	2	-	10	bits
Flash memory	У					
t _{init}	Initialization time.		-	-	150	μs
t _{wr(pg)}	Page write time.		0.95	1	1.05	ms
t _{er(sect)}	Sector erase time.		95	100	105	ms
t _{fl(BIST)}	Flash word BIST time.		-	38	70	ns
t _{acc(clk)}	clock access time		-	-	63.4	ns
t _{acc(addr)}	address access time		-	-	60.3	ns
external station	c memory controller					
t _{a(R)int}	Internal read-access time.		-	-	20.5	ns

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Table 31. Dynamic characteristics ...continued

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DD(A3V3)} = 3.0$ V to 3.6 V; $T_{vj} = -40$ °C; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
t _{a(W)int}	Internal write-access time.		-	-	24.9	ns	00
UART							
f _{UART}	UART frequency.		$1_{65024} f_{clk(uart)}$	-	$1/2 f_{clk(uart)}$	MHz	
SPI							
f _{SPI}	SPI operating frequency.	Master operation.	¹ / ₆₅₀₂₄ f _{clk(spi)}	-	¹ / ₂ f _{clk(spi)}	MHz	
		Slave operation.	¹ /65024 f clk(spi)	-	¹ / ₄ f _{clk(spi)}	MHz	
Jitter Specifica	ation						
CANt _{jit(cc)(p-p)}	CAN TXD pin Cycle-to-cycle jitter (peak-to-peak value).	[2]	-	0.4	1	ns	

[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at T_{amb} = 125 °C ambient temperature on wafer level. Cased products are tested at T_{amb} = 25 °C (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power supply voltage range.

[2] This parameter is not part of production testing or final testing, hence only a typical value is stated.

[3] Oscillator start-up time depends on the quality of the crystal. For most crystals it takes about 1000 clock pulses until the clock is fully stable.

[4] Duty cycle clock should be as close as possible to 50%.

ARM9 microcontroller with CAN and LI RACT DRA

13. Package outline

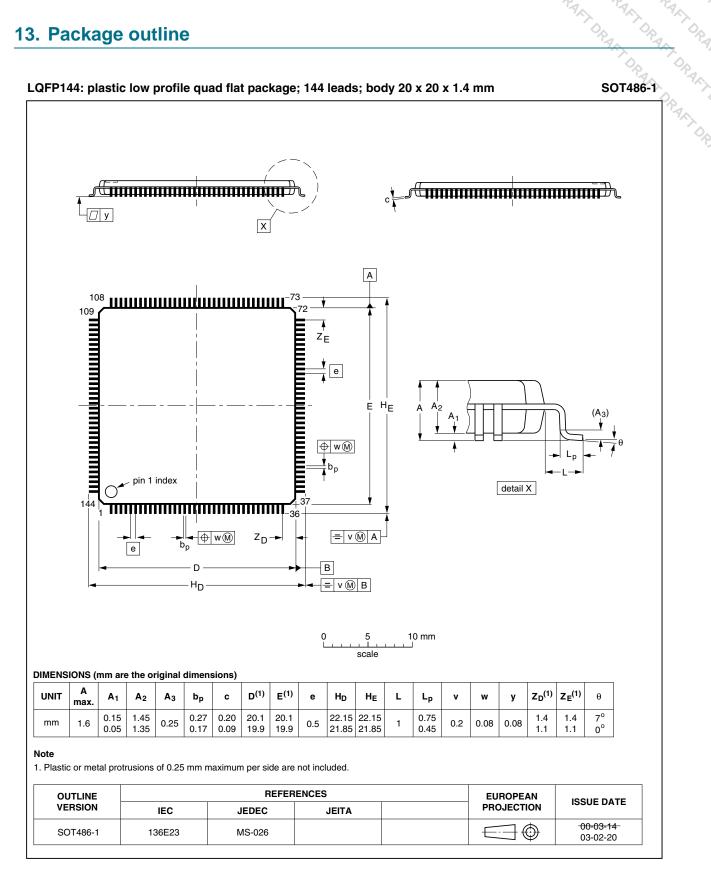


Fig 15. Package outline SOT486-1 (LQFP144)

WIL. ARM9 microcontroller with CAN and LIN AL DRAFT DRAF

14. Soldering

14.1 Introduction

T DRAK There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

14.2 Through-hole mount packages

14.2.1 Soldering by dipping or by solder wave

Typical dwell time of the leads in the wave ranges from 3 seconds to 4 seconds at 250 °C or 265 °C, depending on solder material applied, SnPb or Pb-free respectively.

The total contact time of successive solder waves must not exceed 5 seconds.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified maximum storage temperature (T_{sta(max)}). If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

14.2.2 Manual soldering

Apply the soldering iron (24 V or less) to the lead(s) of the package, either below the seating plane or not more than 2 mm above it. If the temperature of the soldering iron bit is less than 300 °C it may remain in contact for up to 10 seconds. If the bit temperature is between 300 °C and 400 °C, contact may be up to 5 seconds.

14.3 Surface mount packages

14.3.1 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see Figure 16) than a PbSn process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 32 and 33



		ARM9 microcontroller with C	AN and LIN
Table 32. SnPb eutectic	process (from J-STE	D-020C)	DR DR
Package thickness (mm)	Package reflow te	mperature (°C)	~
	Volume (mm ³)		PAR
	< 350	≥ 350	6
< 2.5	235	220	7
≥ 2.5	220	220	(Dp

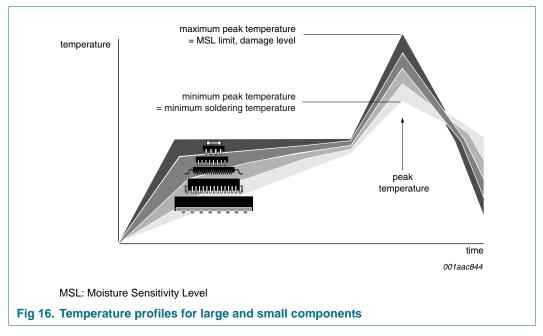
SnPb eutectic process (from J-STD-020C) Table 32

Table 33. Lead-free process (from J-STD-020C)

Package thickness (mm)	Package reflow temperature (°C)				
	Volume (mm ³)				
	< 350	350 to 2000	> 2000		
< 1.6	260	260	260		
1.6 to 2.5	260	250	245		
> 2.5	250	245	245		

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 16.



For further information on temperature profiles, refer to Application Note AN10365 "Surface mount reflow soldering description".

14.3.2 Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

Dpar

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
 - larger than or equal to 1.27 mm, the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;
 - smaller than 1.27 mm, the footprint longitudinal axis **must** be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

• For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time of the leads in the wave ranges from 3 seconds to 4 seconds at 250 °C or 265 °C, depending on solder material applied, SnPb or Pb-free respectively.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

14.3.3 Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 $^{\circ}$ C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 seconds to 5 seconds between 270 $^\circ C$ and 320 $^\circ C.$

14.4 Package related soldering information

Table 34. Suitability of IC packages for wave, reflow and dipping soldering methods

Mounting	Package ^[1]	Soldering method			
		Wave	Reflow ^[2]	Dipping	
Through-hole mount	CPGA, HCPGA	suitable	_	-	
	DBS, DIP, HDIP, RDBS, SDIP, SIL	suitable ^[3]	-	suitable	
Through-hole-surface mount	PMFP ^[4]	not suitable	not suitable	-	

	ARM9 microcontroller with CAN and L						
Table 34. Suitabili Mounting	ity of IC packages for wave, reflow and Package ^[1]	I dipping soldering method Soldering method	scontinued	Op Op OPA			
-		Wave	Reflow ^[2]	Dipping			
Surface mount	BGA, HTSSONT ^[5] , LBGA, LFBGA, SQFP, SSOPT ^[5] , TFBGA, VFBGA, XSON	not suitable	suitable	- TORARTO			
	DHVQFN, HBCC, HBGA, HLQFP, HSO, HSOP, HSQFP, HSSON, HTQFP, HTSSOP, HVQFN, HVSON, SMS	not suitable ^[6]	suitable	OR ₄			
	PLCC ^[7] , SO, SOJ	suitable	suitable	_			
	LQFP, QFP, TQFP	not recommended ^{[7][8]}	suitable	_			
	SSOP, TSSOP, VSO, VSSOP	not recommended ^[9]	suitable	_			
	CWQCCNL ^[10] , WQCCNL ^[10]	not suitable	not suitable	_			

Table 34. Suitability of IC packages for wave, reflow and dipping soldering methods ... continued

For more detailed information on the BGA packages refer to the (LF)BGA Application Note (AN01026); order a copy from your NXP [1] Semiconductors sales office.

All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with [2] respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect).

- For SDIP packages, the longitudinal axis must be parallel to the transport direction of the printed-circuit board. [3]
- [4] Hot bar soldering or manual soldering is suitable for PMFP packages.
- These transparent plastic packages are extremely sensitive to reflow soldering conditions and must on no account be processed [5] through more than one soldering cycle or subjected to infrared reflow soldering with peak temperature exceeding 217 °C ± 10 °C measured in the atmosphere of the reflow oven. The package body peak temperature must be kept as low as possible.
- These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate [6] between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
- [7] If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- Wave soldering is suitable for LQFP, QFP and TQFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for [8] packages with a pitch (e) equal to or smaller than 0.65 mm.
- Wave soldering is suitable for SSOP, TSSOP, VSO and VSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely [9] not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.
- [10] Image sensor packages in principle should not be soldered. They are mounted in sockets or delivered pre-mounted on flex foil. However, the image sensor package can be mounted by the client on a flex foil by using a hot bar soldering process. The appropriate soldering profile can be provided on request.

15. Abbreviations

		LPC2917/19
C	ctors	
		ARM9 microcontroller with CAN and LIN
		RAN RAN RAN
0	ons	
_		· · · · · · · · · · · · · · · · · · ·
	Table 35. Abbr	reviations list
	Abbreviation	Description
	АНВ	Advanced High-performance Bus
	BCL	Buffer Control List
	BDL	Buffer Descriptor List
	CISC	Complex Instruction Set Computers
	DTL	Device Transaction Level
	SFSP	SCU Function Select Port x,y (use without the P if there are no x,y)
	SCL	Slot Control List
	BEL	Buffer Entry List
	CCO	Current Controlled Oscillator
	BIST	Built-In Self Test
	RISC	Reduced Instruction Set Computer
	UART	Universal Asynchronous Receiver Transmitter
	VPB	VLSI Peripheral bus

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16. References

- UM LPC2917/19 user manual [1]
- [2] ARM — ARM web site
- AN and AN and DRAFT DRAFT DRAFT DRAFT DRAFT DRAFT D RAFT DRAFT D RAFT DRAFT D RAFT D RA ARM-SSP — ARM primecell synchronous serial port (PL022) technical reference [3] manual
- CAN ISO 11898-1: 2002 road vehicles Controller Area Network (CAN) part 1: [4] data link layer and physical signalling
- LIN LIN specification package, revision 2.0 [5]



LPC2917/19

17. Revision history

Table 36. Revision h	istory			PAL	PAN
Document ID	Release date	Data sheet status	Change notice	Supersedes	6
LPC2917_19_1.01	<tbd></tbd>	Preliminary data sheet		LPC2915_17_19_1	T.
Modifications	 Part LPC29 	15 removed			Op.
	 Editorial up 	dates			4
LPC2915_17_19_1	20070917	Preliminary data sheet			

18. Legal information

18.1 Data sheet status

NXP Semiconduct	tors	LPC2917/19
		ARM9 microcontroller with CAN and LIN
		RAN RAN RAN P
18. Legal inform	nation	DRAC DRAC DRAC
18.1 Data sheet s	status	TORALL ORALL OF
Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

Please consult the most recently issued document before initiating or completing a design. [1]

[2] The term 'short data sheet' is explained in section "Definitions".

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